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April 1st, 2010
Renesas Electronics Corporation

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1. Overview

These MCUs are fabricated using a high-performance silicon gate CMOS process, embedding the R8C/Tiny Series CPU core, and are packaged in a 52-pin molded-plastic LQFP or a 64-pin molded-plastic FLGA. It implements sophisticated instructions for a high level of instruction efficiency. With 1 Mbyte of address space, they are capable of executing instructions at high speed.

Furthermore, the R8C/25 Group has on-chip data flash (1 KB x 2 blocks).

The difference between the R8C/24 Group and R8C/25 Group is only the presence or absence of data flash. Their peripheral functions are the same.

1.1 Applications

Electronic household appliances, office equipment, audio equipment, consumer products, etc.

1.2 Performance Overview

Table 1.1 outlines the Functions and Specifications for R8C/24 Group and Table 1.2 outlines the Functions and Specifications for R8C/25 Group.

Table 1.1 Functions and Specifications for R8C/24 Group

| Item | | Specification | |
|-------------------------------|-------------------------------------|--|--|
| CPU | Number of fundamental instructions | 89 instructions | |
| | Minimum instruction execution time | 50 ns (f(XIN) = 20 MHz, VCC = 3.0 to 5.5 V) 100 ns (f(XIN) = 10 MHz, VCC = 2.7 to 5.5 V) 200 ns (f(XIN) = 5 MHz, VCC = 2.2 to 5.5 V) | |
| | Operating mode | Single-chip | |
| | Address space | 1 Mbyte | |
| | Memory capacity | Refer to Table 1.3 Product Information for R8C/24 Group | |
| Peripheral Functions | Ports | I/O ports: 41 pins, Input port: 3 pins | |
| | LED drive ports | I/O ports: 8 pins | |
| | Timers | Timer RA: 8 bits × 1 channel Timer RB: 8 bits × 1 channel (Each timer equipped with 8-bit prescaler) Timer RD: 16 bits × 2 channels (Input capture and output compare circuits) Timer RE: With real-time clock and compare match function | |
| | Serial interfaces | 2 channels (UART0, UART1) Clock synchronous serial I/O, UART | |
| | Clock synchronous serial interface | 1 channel I ² C bus Interface ⁽¹⁾ Clock synchronous serial I/O with chip select | |
| | LIN module | Hardware LIN: 1 channel (timer RA, UART0) | |
| | A/D converter | 10-bit A/D converter: 1 circuit, 12 channels | |
| | Watchdog timer | 15 bits × 1 channel (with prescaler) Reset start selectable | |
| | Interrupts | Internal: 11 sources, External: 5 sources, Software: 4 sources, Priority levels: 7 levels | |
| | Clock | Clock generation circuits | 3 circuits <ul style="list-style-type: none"> XIN clock generation circuit (with on-chip feedback resistor) On-chip oscillator (high speed, low speed) High-speed on-chip oscillator has a frequency adjustment function XCIN clock generation circuit (32 kHz) |
| | | | Real-time clock (timer RE) |
| | Oscillation stop detection function | XIN clock oscillation stop detection function | |
| | Voltage detection circuit | On-chip | |
| | Power-on reset circuit | On-chip | |
| Electrical Characteristics | Supply voltage | VCC = 3.0 to 5.5 V (f(XIN) = 20 MHz) VCC = 2.7 to 5.5 V (f(XIN) = 10 MHz) VCC = 2.2 to 5.5 V (f(XIN) = 5 MHz) | |
| | Current consumption | Typ. 10 mA (VCC = 5.0 V, f(XIN) = 20 MHz) Typ. 6 mA (VCC = 3.0 V, f(XIN) = 10 MHz) Typ. 2.0 μA (VCC = 3.0 V, wait mode (f(XCIN) = 32 kHz)) Typ. 0.7 μA (VCC = 3.0 V, stop mode) | |
| Flash Memory | Programming and erasure voltage | VCC = 2.7 to 5.5 V | |
| | Programming and erasure endurance | 100 times | |
| Operating Ambient Temperature | | -20 to 85°C (N version) | |
| | | -40 to 85°C (D version) ⁽²⁾ | |
| | | -20 to 105°C (Y version) ⁽³⁾ | |
| Package | | 52-pin molded-plastic LQFP | |
| | | 64-pin molded-plastic FLGA | |

NOTES:

- I²C bus is a trademark of Koninklijke Philips Electronics N. V.
- Specify the D version if D version functions are to be used.
- Please contact Renesas Technology sales offices for the Y version.

Table 1.2 Functions and Specifications for R8C/25 Group

| Item | | Specification | |
|-------------------------------|------------------------------------|---|--|
| CPU | Number of fundamental instructions | 89 instructions | |
| | Minimum instruction execution time | 50 ns ($f(XIN) = 20$ MHz, $VCC = 3.0$ to 5.5 V) 100 ns ($f(XIN) = 10$ MHz, $VCC = 2.7$ to 5.5 V) 200 ns ($f(XIN) = 5$ MHz, $VCC = 2.2$ to 5.5 V) | |
| | Operating mode | Single-chip | |
| | Address space | 1 Mbyte | |
| | Memory capacity | Refer to Table 1.4 Product Information for R8C/25 Group | |
| Peripheral Functions | Ports | I/O ports: 41 pins, Input port: 3 pins | |
| | LED drive ports | I/O ports: 8 pins | |
| | Timers | Timer RA: 8 bits \times 1 channel Timer RB: 8 bits \times 1 channel (Each timer equipped with 8-bit prescaler) Timer RD: 16 bits \times 2 channels (Input capture and output compare circuits) Timer RE: With real-time clock and compare match function | |
| | Serial interface | 2 channels (UART0, UART1) Clock synchronous serial I/O, UART | |
| | Clock synchronous serial interface | 1 channel I ² C bus Interface ⁽¹⁾ Clock synchronous serial I/O with chip select | |
| | LIN module | Hardware LIN: 1 channel (timer RA, UART0) | |
| | A/D converter | 10-bit A/D converter: 1 circuit, 12 channels | |
| | Watchdog timer | 15 bits \times 1 channel (with prescaler) Reset start selectable | |
| | Interrupts | Internal: 11 sources, External: 5 sources, Software: 4 sources, Priority levels: 7 levels | |
| | Clock | Clock generation circuits | 3 circuits <ul style="list-style-type: none"> XIN clock generation circuit (with on-chip feedback resistor) On-chip oscillator (high speed, low speed) High-speed on-chip oscillator has a frequency adjustment function XCIN clock generation circuit (32 kHz) |
| | | | Real-time clock (timer RE) |
| | | Oscillation stop detection function | XIN clock oscillation stop detection function |
| | | Voltage detection circuit | On-chip |
| | | Power-on reset circuit | On-chip |
| Electrical Characteristics | Supply voltage | $VCC = 3.0$ to 5.5 V ($f(XIN) = 20$ MHz) $VCC = 2.7$ to 5.5 V ($f(XIN) = 10$ MHz) $VCC = 2.2$ to 5.5 V ($f(XIN) = 5$ MHz) | |
| | Current consumption | Typ. 10 mA ($VCC = 5.0$ V, $f(XIN) = 20$ MHz) Typ. 6 mA ($VCC = 3.0$ V, $f(XIN) = 10$ MHz) Typ. 2.0 μ A ($VCC = 3.0$ V, wait mode ($f(XCIN) = 32$ kHz)) Typ. 0.7 μ A ($VCC = 3.0$ V, stop mode) | |
| Flash memory | Programming and erasure voltage | $VCC = 2.7$ to 5.5 V | |
| | Programming and erasure endurance | 1,000 times (data flash) 1,000 times (program ROM) | |
| Operating Ambient Temperature | | -20 to 85°C (N version) -40 to 85°C (D version) ⁽²⁾ -20 to 105°C (Y version) ⁽³⁾ | |
| | | | |
| | | | |
| Package | | 52-pin molded-plastic LQFP 64-pin molded-plastic FLGA | |
| | | | |

NOTES:

- I²C bus is a trademark of Koninklijke Philips Electronics N. V.
- Specify the D version if D version functions are to be used.
- Please contact Renesas Technology sales offices for the Y version.

1.3 Block Diagram

Figure 1.1 shows a Block Diagram.

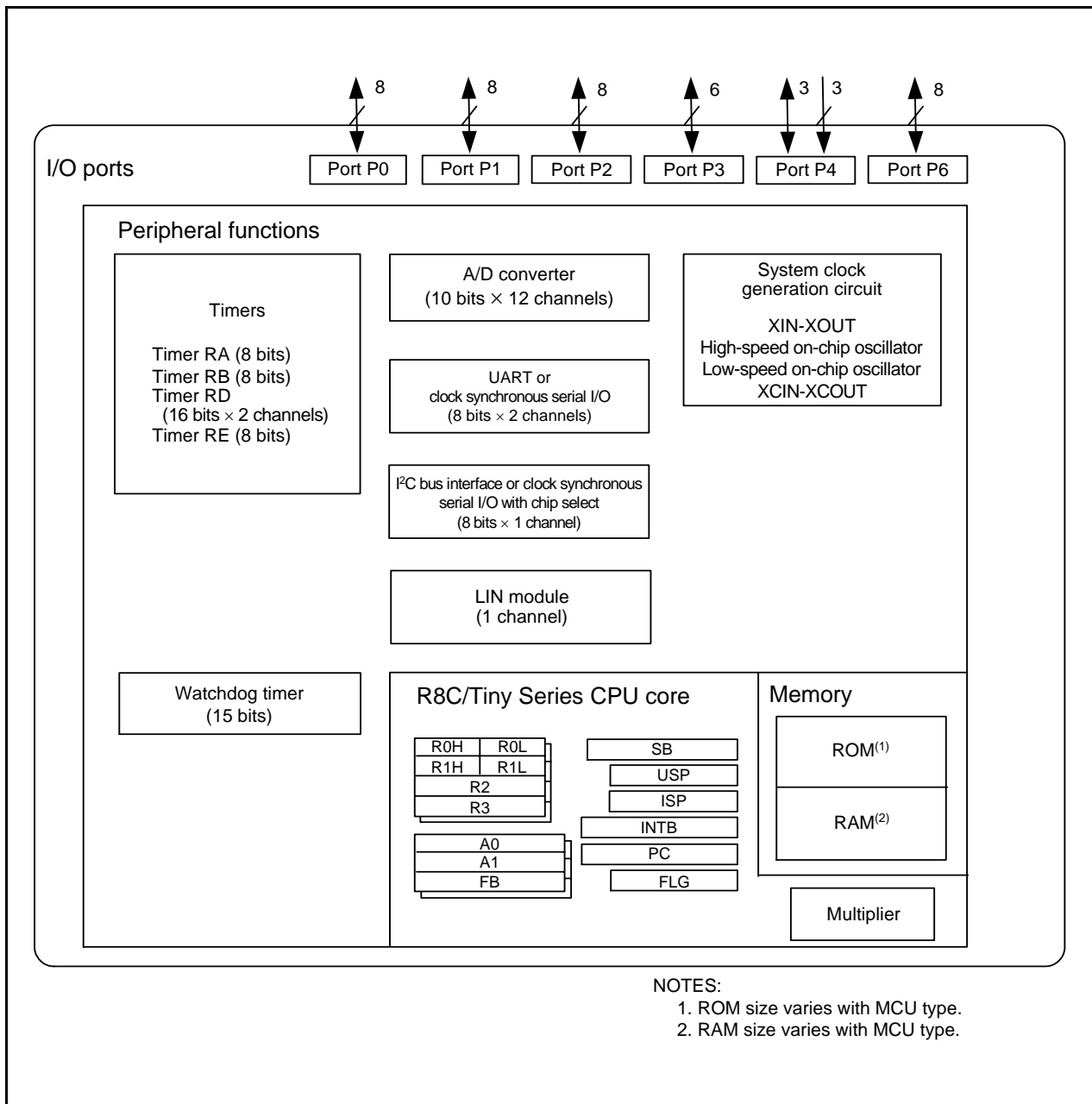


Figure 1.1 Block Diagram

1.4 Product Information

Table 1.3 lists the Product Information for R8C/24 Group and Table 1.4 lists the Product Information for R8C/25 Group.

Table 1.3 Product Information for R8C/24 Group

Current of Feb. 2008

| Type No. | ROM Capacity | RAM Capacity | Package Type | Remarks |
|-----------------|--------------|--------------|--------------|---|
| R5F21244SNFP | 16 Kbytes | 1 Kbyte | PLQP0052JA-A | N version Blank product |
| R5F21245SNFP | 24 Kbytes | 2 Kbytes | PLQP0052JA-A | |
| R5F21246SNFP | 32 Kbytes | 2 Kbytes | PLQP0052JA-A | |
| R5F21247SNFP | 48 Kbytes | 2.5 Kbytes | PLQP0052JA-A | |
| R5F21248SNFP | 64 Kbytes | 3 Kbytes | PLQP0052JA-A | |
| R5F21244SNLG | 16 Kbytes | 1 Kbyte | PTLG0064JA-A | |
| R5F21246SNLG | 32 Kbytes | 2 Kbytes | PTLG0064JA-A | |
| R5F21244SDFP | 16 Kbytes | 1 Kbyte | PLQP0052JA-A | D version Blank product |
| R5F21245SDFP | 24 Kbytes | 2 Kbytes | PLQP0052JA-A | |
| R5F21246SDFP | 32 Kbytes | 2 Kbytes | PLQP0052JA-A | |
| R5F21247SDFP | 48 Kbytes | 2.5 Kbytes | PLQP0052JA-A | |
| R5F21248SDFP | 64 Kbytes | 3 Kbytes | PLQP0052JA-A | |
| R5F21244SNXXXFP | 16 Kbytes | 1 Kbyte | PLQP0052JA-A | N version Factory programming product ⁽¹⁾ |
| R5F21245SNXXXFP | 24 Kbytes | 2 Kbytes | PLQP0052JA-A | |
| R5F21246SNXXXFP | 32 Kbytes | 2 Kbytes | PLQP0052JA-A | |
| R5F21247SNXXXFP | 48 Kbytes | 2.5 Kbytes | PLQP0052JA-A | |
| R5F21248SNXXXFP | 64 Kbytes | 3 Kbytes | PLQP0052JA-A | |
| R5F21244SNXXXLG | 16 Kbytes | 1 Kbyte | PTLG0064JA-A | |
| R5F21246SNXXXLG | 32 Kbytes | 2 Kbytes | PTLG0064JA-A | |
| R5F21244SDXXXFP | 16 Kbytes | 1 Kbyte | PLQP0052JA-A | D version Factory programming product ⁽¹⁾ |
| R5F21245SDXXXFP | 24 Kbytes | 2 Kbytes | PLQP0052JA-A | |
| R5F21246SDXXXFP | 32 Kbytes | 2 Kbytes | PLQP0052JA-A | |
| R5F21247SDXXXFP | 48 Kbytes | 2.5 Kbytes | PLQP0052JA-A | |
| R5F21248SDXXXFP | 64 Kbytes | 3 Kbytes | PLQP0052JA-A | |

NOTE:

1. The user ROM is programmed before shipment.

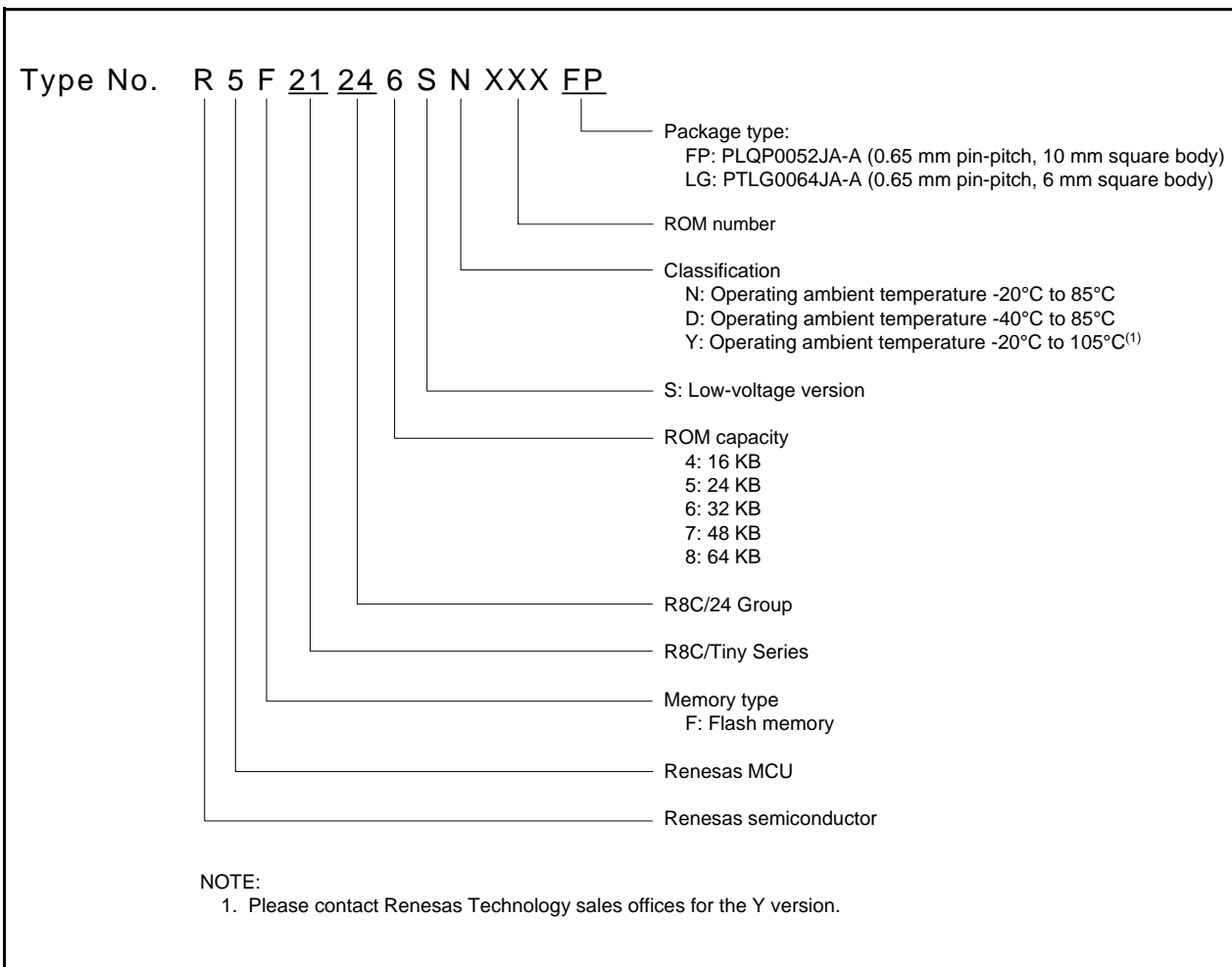


Figure 1.2 Type Number, Memory Size, and Package of R8C/24 Group

Table 1.4 Product Information for R8C/25 Group

Current of Feb. 2008

| Type No. | ROM Capacity | | RAM Capacity | Package Type | Remarks |
|-----------------|--------------|-------------|--------------|--------------|---|
| | Program ROM | Data flash | | | |
| R5F21254SNFP | 16 Kbytes | 1 Kbyte × 2 | 1 Kbyte | PLQP0052JA-A | N version Blank product |
| R5F21255SNFP | 24 Kbytes | 1 Kbyte × 2 | 2 Kbytes | PLQP0052JA-A | |
| R5F21256SNFP | 32 Kbytes | 1 Kbyte × 2 | 2 Kbytes | PLQP0052JA-A | |
| R5F21257SNFP | 48 Kbytes | 1 Kbyte × 2 | 2.5 Kbytes | PLQP0052JA-A | |
| R5F21258SNFP | 64 Kbytes | 1 Kbyte × 2 | 3 Kbytes | PLQP0052JA-A | |
| R5F21254SNLG | 16 Kbytes | 1 Kbyte × 2 | 1 Kbyte | PTLG0064JA-A | |
| R5F21256SNLG | 32 Kbytes | 1 Kbyte × 2 | 2 Kbytes | PTLG0064JA-A | D version Blank product |
| R5F21254SDFP | 16 Kbytes | 1 Kbyte × 2 | 1 Kbyte | PLQP0052JA-A | |
| R5F21255SDFP | 24 Kbytes | 1 Kbyte × 2 | 2 Kbytes | PLQP0052JA-A | |
| R5F21256SDFP | 32 Kbytes | 1 Kbyte × 2 | 2 Kbytes | PLQP0052JA-A | |
| R5F21257SDFP | 48 Kbytes | 1 Kbyte × 2 | 2.5 Kbytes | PLQP0052JA-A | |
| R5F21258SDFP | 64 Kbytes | 1 Kbyte × 2 | 3 Kbytes | PLQP0052JA-A | |
| R5F21254SNXXXFP | 16 Kbytes | 1 Kbyte × 2 | 1 Kbyte | PLQP0052JA-A | N version Factory programming product ⁽¹⁾ |
| R5F21255SNXXXFP | 24 Kbytes | 1 Kbyte × 2 | 2 Kbytes | PLQP0052JA-A | |
| R5F21256SNXXXFP | 32 Kbytes | 1 Kbyte × 2 | 2 Kbytes | PLQP0052JA-A | |
| R5F21257SNXXXFP | 48 Kbytes | 1 Kbyte × 2 | 2.5 Kbytes | PLQP0052JA-A | |
| R5F21258SNXXXFP | 64 Kbytes | 1 Kbyte × 2 | 3 Kbytes | PLQP0052JA-A | |
| R5F21254SNXXXLG | 16 Kbytes | 1 Kbyte × 2 | 1 Kbyte | PTLG0064JA-A | |
| R5F21256SNXXXLG | 32 Kbytes | 1 Kbyte × 2 | 2 Kbytes | PTLG0064JA-A | D version Factory programming product ⁽¹⁾ |
| R5F21254SDXXXFP | 16 Kbytes | 1 Kbyte × 2 | 1 Kbyte | PLQP0052JA-A | |
| R5F21255SDXXXFP | 24 Kbytes | 1 Kbyte × 2 | 2 Kbytes | PLQP0052JA-A | |
| R5F21256SDXXXFP | 32 Kbytes | 1 Kbyte × 2 | 2 Kbytes | PLQP0052JA-A | |
| R5F21257SDXXXFP | 48 Kbytes | 1 Kbyte × 2 | 2.5 Kbytes | PLQP0052JA-A | |
| R5F21258SDXXXFP | 64 Kbytes | 1 Kbyte × 2 | 3 Kbytes | PLQP0052JA-A | |

NOTE:

1. The user ROM is programmed before shipment.

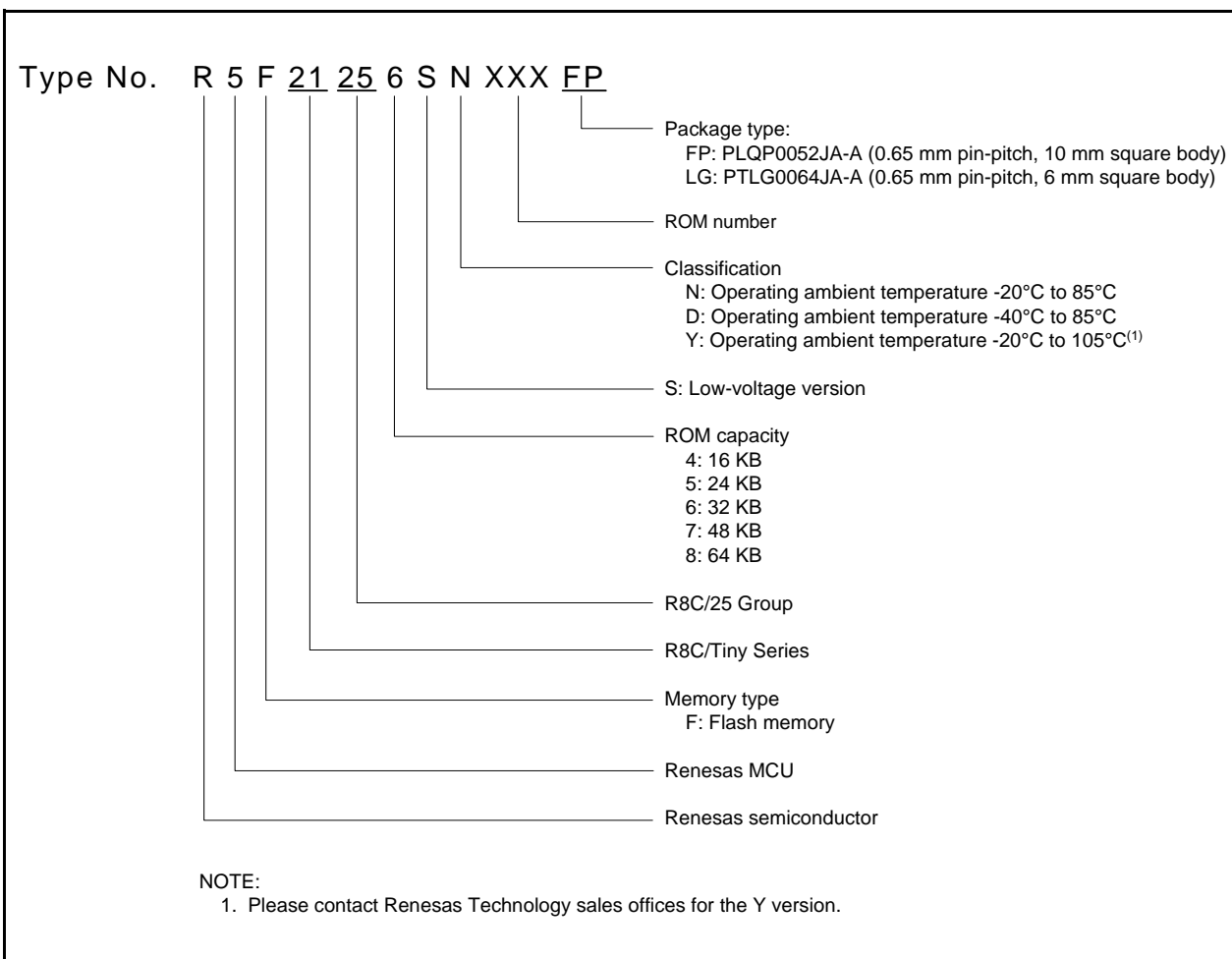


Figure 1.3 Type Number, Memory Size, and Package of R8C/25 Group

1.5 Pin Assignments

Figure 1.4 shows PLQP0052JA-A Package Pin Assignments (Top View). Figure 1.5 shows PTLG0064JA-A Package Pin Assignments.

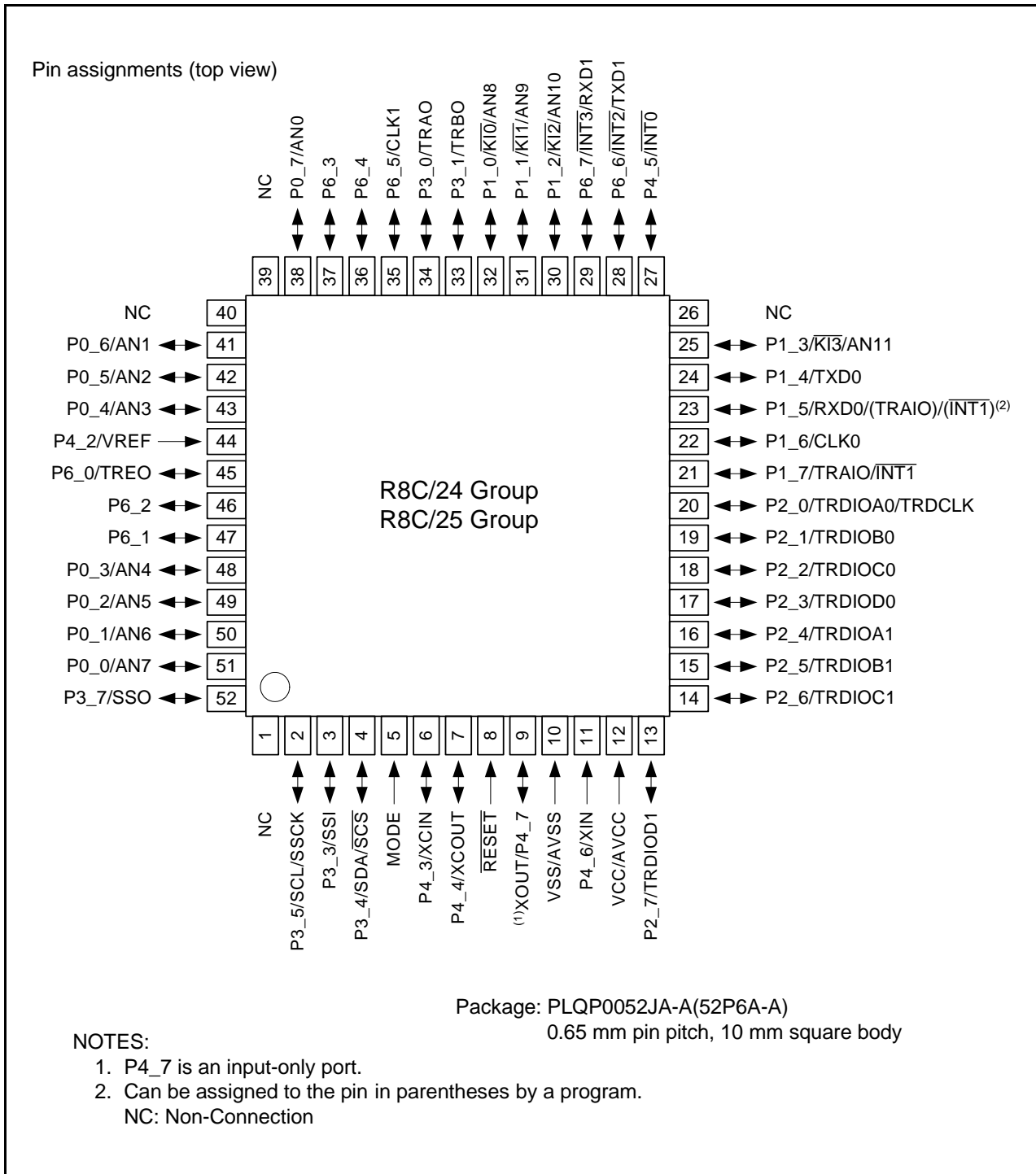


Figure 1.4 PLQP0052JA-A Package Pin Assignments (Top View)

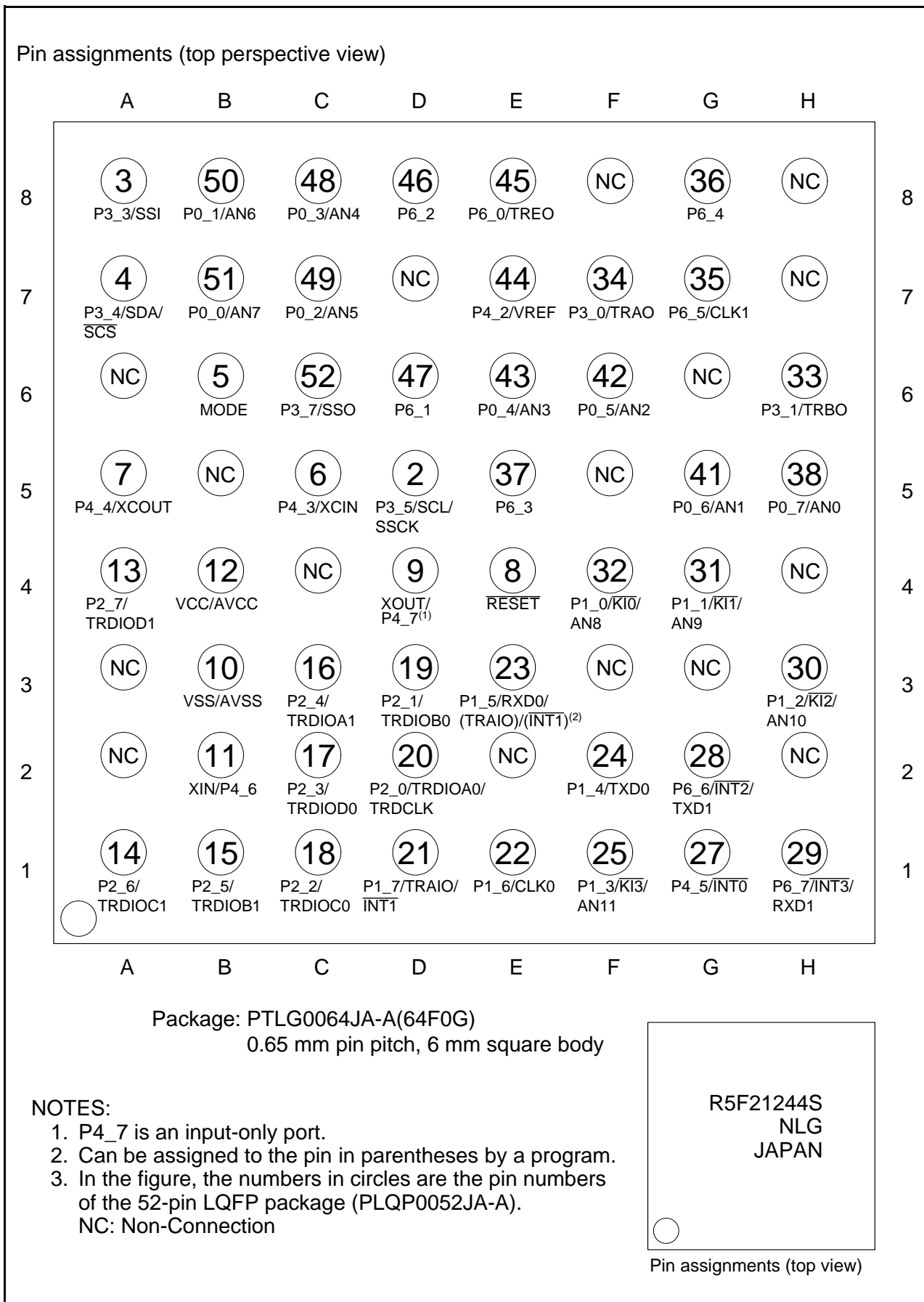


Figure 1.5 PTLG0064JA-A Package Pin Assignments

1.6 Pin Functions

Table 1.5 lists Pin Functions.

Table 1.5 Pin Functions

| Type | Symbol | I/O Type | Description |
|---|--|----------|---|
| Power supply input | VCC, VSS | I | Apply 2.2 V to 5.5 V to the VCC pin. Apply 0 V to the VSS pin. |
| Analog power supply input | AVCC, AVSS | I | Power supply for the A/D converter. Connect a capacitor between AVCC and AVSS. |
| Reset input | $\overline{\text{RESET}}$ | I | Input "L" on this pin resets the MCU. |
| MODE | MODE | I | Connect this pin to VCC via a resistor. |
| XIN clock input | XIN | I | These pins are provided for XIN clock generation circuit I/O. Connect a ceramic resonator or a crystal oscillator between the XIN and XOUT pins. To use an external clock, input it to the XIN pin and leave the XOUT pin open. |
| XIN clock output | XOUT | O | |
| XCIN clock input | XCIN | I | These pins are provided for XCIN clock generation circuit I/O. Connect a crystal oscillator between the XCIN and XCOUT pins. To use an external clock, input it to the XCIN pin and leave the XCOUT pin open. |
| XCIN clock output | XCOUT | O | |
| $\overline{\text{INT}}$ interrupt input | $\overline{\text{INT0}}$ to $\overline{\text{INT3}}$ | I | $\overline{\text{INT}}$ interrupt input pins. $\overline{\text{INT0}}$ is timer RD input pin. $\overline{\text{INT1}}$ is timer RA input pin. |
| Key input interrupt | $\overline{\text{KI0}}$ to $\overline{\text{KI3}}$ | I | Key input interrupt input pins |
| Timer RA | TRAIO | I/O | Timer RA I/O pin |
| | TRAO | O | Timer RA output pin |
| Timer RB | TRBO | O | Timer RB output pin |
| Timer RD | TRDIOA0, TRDIOA1, TRDIOB0, TRDIOB1, TRDIOC0, TRDIOC1, TRDIOD0, TRDIOD1 | I/O | Timer RD I/O ports |
| | TRDCLK | I | External clock input pin |
| Timer RE | TREO | O | Divided clock output pin |
| Serial interface | CLK0, CLK1 | I/O | Transfer clock I/O pin |
| | RXD0, RXD1 | I | Serial data input pins |
| | TXD0, TXD1 | O | Serial data output pins |
| I ² C bus interface | SCL | I/O | Clock I/O pin |
| | SDA | I/O | Data I/O pin |
| Clock synchronous serial I/O with chip select | SSI | I/O | Data I/O pin |
| | $\overline{\text{SCS}}$ | I/O | Chip-select signal I/O pin |
| | SSCK | I/O | Clock I/O pin |
| | SSO | I/O | Data I/O pin |
| Reference voltage input | VREF | I | Reference voltage input pin to A/D converter |
| A/D converter | AN0 to AN11 | I | Analog input pins to A/D converter |
| I/O port | P0_0 to P0_7, P1_0 to P1_7, P2_0 to P2_7, P3_0, P3_1, P3_3 to P3_5, P3_7, P4_3 to P4_5, P6_0 to P6_7 | I/O | CMOS I/O ports. Each port has an I/O select direction register, allowing each pin in the port to be directed for input or output individually. Any port set to input can be set to use a pull-up resistor or not by a program. P2_0 to P2_7 also function as LED drive ports. |
| Input port | P4_2, P4_6, P4_7 | I | Input-only ports |

I: Input O: Output I/O: Input and output

Table 1.6 Pin Name Information by Pin Number

| Pin Number | Control Pin | Port | I/O Pin Functions for of Peripheral Modules | | | | | |
|------------|-------------|------|---|------------------------|------------------|---|--------------------------------|---------------|
| | | | Interrupt | Timer | Serial Interface | Clock Synchronous Serial I/O with Chip Select | I ² C bus Interface | A/D Converter |
| 2 | | P3_5 | | | | SSCK | SCL | |
| 3 | | P3_3 | | | | SSI | | |
| 4 | | P3_4 | | | | SCS | SDA | |
| 5 | MODE | | | | | | | |
| 6 | XCIN | P4_3 | | | | | | |
| 7 | XCOU | P4_4 | | | | | | |
| 8 | RESET | | | | | | | |
| 9 | XOUT | P4_7 | | | | | | |
| 10 | VSS/AVSS | | | | | | | |
| 11 | XIN | P4_6 | | | | | | |
| 12 | VCC/AVCC | | | | | | | |
| 13 | | P2_7 | | TRDIOD1 | | | | |
| 14 | | P2_6 | | TRDIOC1 | | | | |
| 15 | | P2_5 | | TRDIOB1 | | | | |
| 16 | | P2_4 | | TRDIOA1 | | | | |
| 17 | | P2_3 | | TRDIOD0 | | | | |
| 18 | | P2_2 | | TRDIOC0 | | | | |
| 19 | | P2_1 | | TRDIOB0 | | | | |
| 20 | | P2_0 | | TRDIOA0/TRDCLK | | | | |
| 21 | | P1_7 | INT1 | TRAIO | | | | |
| 22 | | P1_6 | | | CLK0 | | | |
| 23 | | P1_5 | (INT1) ⁽¹⁾ | (TRAIO) ⁽¹⁾ | RXD0 | | | |
| 24 | | P1_4 | | | TXD0 | | | |
| 25 | | P1_3 | K3 | | | | | AN11 |
| 27 | | P4_5 | INT0 | INT0 | | | | |
| 28 | | P6_6 | INT2 | | TXD1 | | | |
| 29 | | P6_7 | INT3 | | RXD1 | | | |
| 30 | | P1_2 | K2 | | | | | AN10 |
| 31 | | P1_1 | K1 | | | | | AN9 |
| 32 | | P1_0 | K0 | | | | | AN8 |
| 33 | | P3_1 | | TRBO | | | | |
| 34 | | P3_0 | | TRA0 | | | | |
| 35 | | P6_5 | | | CLK1 | | | |
| 36 | | P6_4 | | | | | | |
| 37 | | P6_3 | | | | | | |
| 38 | | P0_7 | | | | | | AN0 |
| 41 | | P0_6 | | | | | | AN1 |
| 42 | | P0_5 | | | | | | AN2 |
| 43 | | P0_4 | | | | | | AN3 |
| 44 | VREF | P4_2 | | | | | | |
| 45 | | P6_0 | | TRE0 | | | | |
| 46 | | P6_2 | | | | | | |
| 47 | | P6_1 | | | | | | |
| 48 | | P0_3 | | | | | | AN4 |
| 49 | | P0_2 | | | | | | AN5 |
| 50 | | P0_1 | | | | | | AN6 |
| 51 | | P0_0 | | | | | | AN7 |
| 52 | | P3_7 | | | | SSO | | |

NOTE:

1. Can be assigned to the pin in parentheses by a program.

2. Central Processing Unit (CPU)

Figure 2.1 shows the CPU Registers. The CPU contains 13 registers. R0, R1, R2, R3, A0, A1, and FB configure a register bank. There are two sets of register bank.

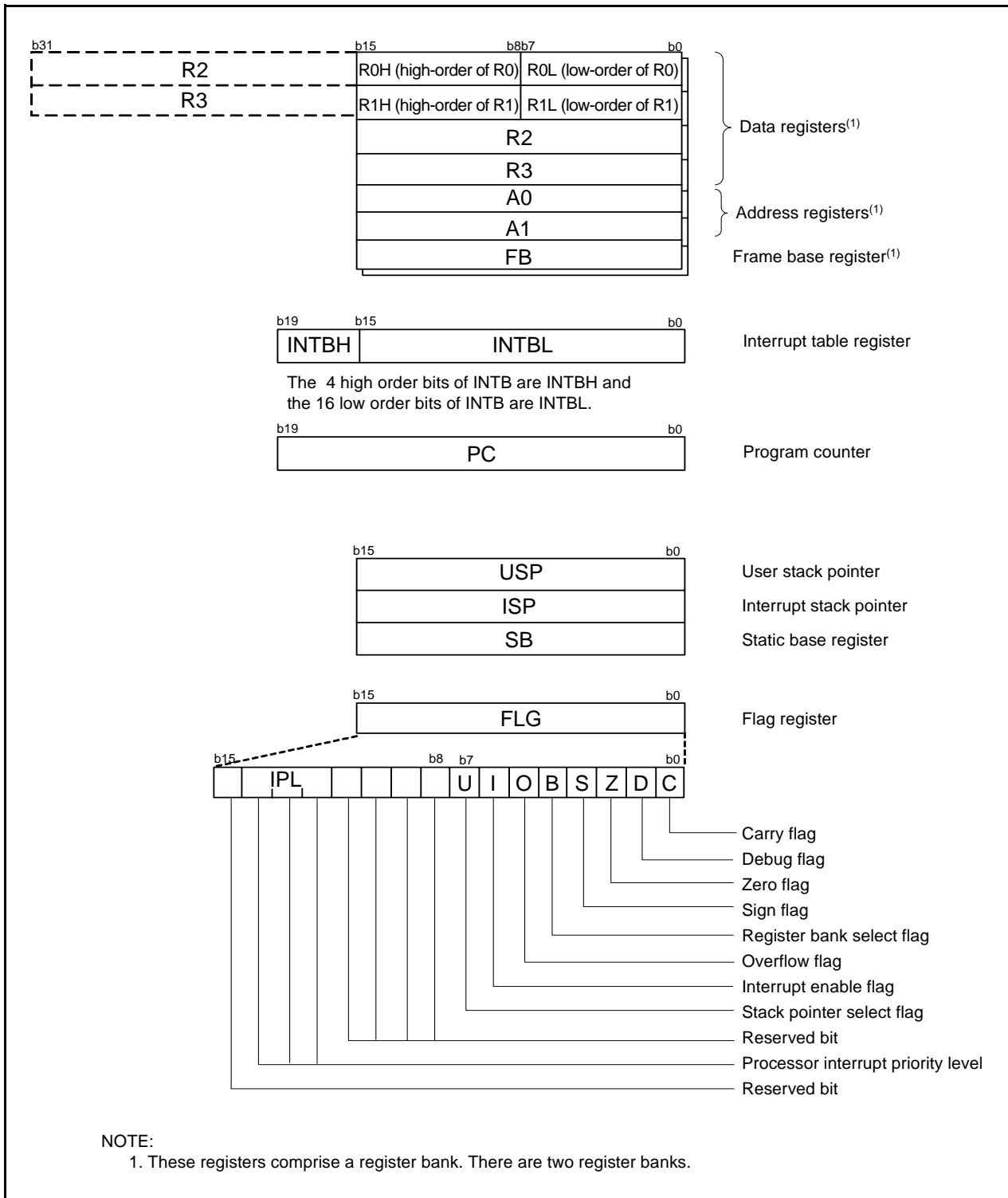


Figure 2.1 CPU Registers

2.1 Data Registers (R0, R1, R2, and R3)

R0 is a 16-bit register for transfer, arithmetic, and logic operations. The same applies to R1 to R3. R0 can be split into high-order bits (R0H) and low-order bits (R0L) to be used separately as 8-bit data registers. R1H and R1L are analogous to R0H and R0L. R2 can be combined with R0 and used as a 32-bit data register (R2R0). R3R1 is analogous to R2R0.

2.2 Address Registers (A0 and A1)

A0 is a 16-bit register for address register indirect addressing and address register relative addressing. It is also used for transfer, arithmetic, and logic operations. A1 is analogous to A0. A1 can be combined with A0 and as a 32-bit address register (A1A0).

2.3 Frame Base Register (FB)

FB is a 16-bit register for FB relative addressing.

2.4 Interrupt Table Register (INTB)

INTB is a 20-bit register that indicates the start address of an interrupt vector table.

2.5 Program Counter (PC)

PC is 20 bits wide and indicates the address of the next instruction to be executed.

2.6 User Stack Pointer (USP) and Interrupt Stack Pointer (ISP)

The stack pointers (SP), USP, and ISP, are each 16 bits wide. The U flag of FLG is used to switch between USP and ISP.

2.7 Static Base Register (SB)

SB is a 16-bit register for SB relative addressing.

2.8 Flag Register (FLG)

FLG is an 11-bit register indicating the CPU state.

2.8.1 Carry Flag (C)

The C flag retains carry, borrow, or shift-out bits that have been generated by the arithmetic and logic unit.

2.8.2 Debug Flag (D)

The D flag is for debugging only. Set it to 0.

2.8.3 Zero Flag (Z)

The Z flag is set to 1 when an arithmetic operation results in 0; otherwise to 0.

2.8.4 Sign Flag (S)

The S flag is set to 1 when an arithmetic operation results in a negative value; otherwise to 0.

2.8.5 Register Bank Select Flag (B)

Register bank 0 is selected when the B flag is 0. Register bank 1 is selected when this flag is set to 1.

2.8.6 Overflow Flag (O)

The O flag is set to 1 when an operation results in an overflow; otherwise to 0.

2.8.7 Interrupt Enable Flag (I)

The I flag enables maskable interrupts.

Interrupt are disabled when the I flag is set to 0, and are enabled when the I flag is set to 1. The I flag is set to 0 when an interrupt request is acknowledged.

2.8.8 Stack Pointer Select Flag (U)

ISP is selected when the U flag is set to 0; USP is selected when the U flag is set to 1.

The U flag is set to 0 when a hardware interrupt request is acknowledged or the INT instruction of software interrupt numbers 0 to 31 is executed.

2.8.9 Processor Interrupt Priority Level (IPL)

IPL is 3 bits wide and assigns processor interrupt priority levels from level 0 to level 7.

If a requested interrupt has higher priority than IPL, the interrupt is enabled.

2.8.10 Reserved Bit

If necessary, set to 0. When read, the content is undefined.

3. Memory

3.1 R8C/24 Group

Figure 3.1 is a Memory Map of R8C/24 Group. The R8C/24 group has 1 Mbyte of address space from addresses 00000h to FFFFFh.

The internal ROM is allocated lower addresses, beginning with address 0FFFFh. For example, a 48-Kbyte internal ROM area is allocated addresses 04000h to 0FFFFh.

The fixed interrupt vector table is allocated addresses 0FFDCh to 0FFFFh. They store the starting address of each interrupt routine.

The internal RAM is allocated higher addresses, beginning with address 00400h. For example, a 2-Kbyte internal RAM area is allocated addresses 00400h to 00BFFh. The internal RAM is used not only for storing data but also for calling subroutines and as stacks when interrupt requests are acknowledged.

Special function registers (SFRs) are allocated addresses 00000h to 002FFh. The peripheral function control registers are allocated here. All addresses within the SFR, which have nothing allocated are reserved for future use and cannot be accessed by users.

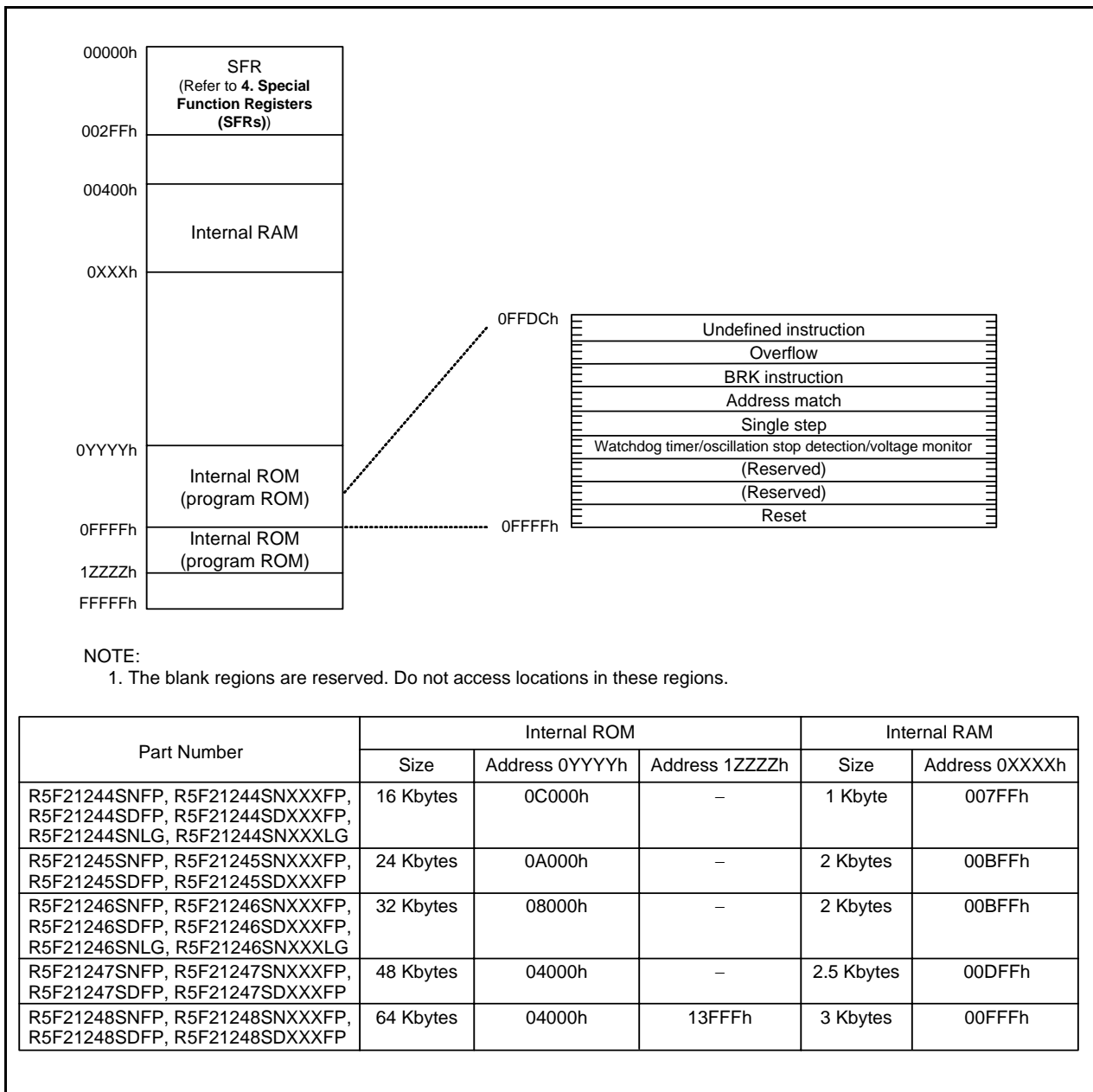


Figure 3.1 Memory Map of R8C/24 Group

3.2 R8C/25 Group

Figure 3.2 is a Memory Map of R8C/25 Group. The R8C/25 group has 1 Mbyte of address space from addresses 00000h to FFFFFh.

The internal ROM (program ROM) is allocated lower addresses, beginning with address 0FFFFh. For example, a 48-Kbyte internal ROM area is allocated addresses 04000h to 0FFFFh.

The fixed interrupt vector table is allocated addresses 0FFDCh to 0FFFFh. They store the starting address of each interrupt routine.

The internal ROM (data flash) is allocated addresses 02400h to 02BFFh.

The internal RAM area is allocated higher addresses, beginning with address 00400h. For example, a 2-Kbyte internal RAM is allocated addresses 00400h to 00BFFh. The internal RAM is used not only for storing data but also for calling subroutines and as stacks when interrupt requests are acknowledged.

Special function registers (SFRs) are allocated addresses 00000h to 002FFh. The peripheral function control registers are allocated here. All addresses within the SFR, which have nothing allocated are reserved for future use and cannot be accessed by users.

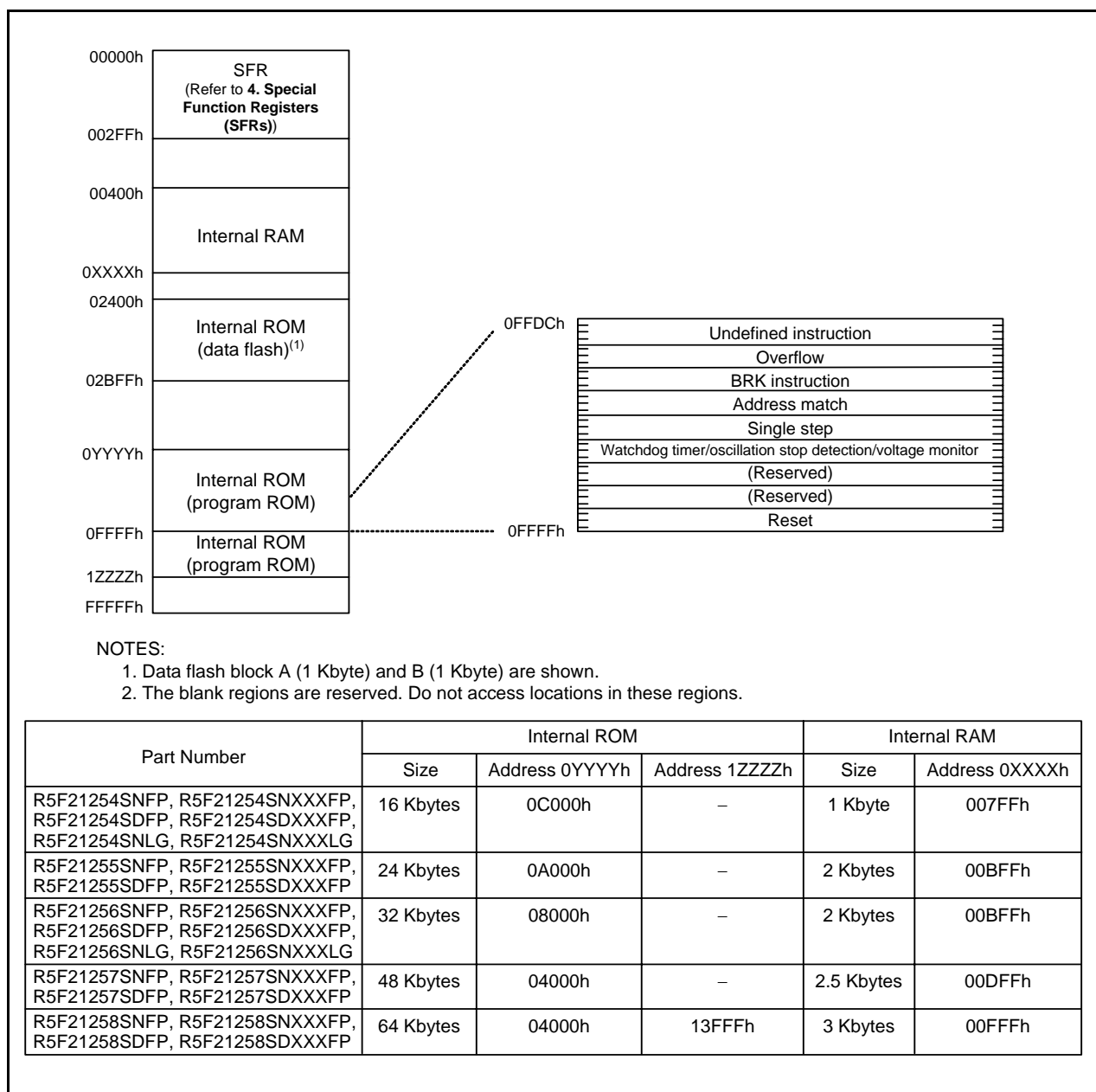


Figure 3.2 Memory Map of R8C/25 Group

4. Special Function Registers (SFRs)

An SFR (special function register) is a control register for a peripheral function. Tables 4.1 to 4.7 list the special function registers.

Table 4.1 SFR Information (1)(1)

| Address | Register | Symbol | After reset |
|---------|---|--------|--|
| 0000h | | | |
| 0001h | | | |
| 0002h | | | |
| 0003h | | | |
| 0004h | Processor Mode Register 0 | PM0 | 00h |
| 0005h | Processor Mode Register 1 | PM1 | 00h |
| 0006h | System Clock Control Register 0 | CM0 | 01101000b |
| 0007h | System Clock Control Register 1 | CM1 | 00100000b |
| 0008h | | | |
| 0009h | | | |
| 000Ah | Protect Register | PRCR | 00h |
| 000Bh | | | |
| 000Ch | Oscillation Stop Detection Register | OCD | 00000100b |
| 000Dh | Watchdog Timer Reset Register | WDTR | XXh |
| 000Eh | Watchdog Timer Start Register | WDTS | XXh |
| 000Fh | Watchdog Timer Control Register | WDC | 00X11111b |
| 0010h | Address Match Interrupt Register 0 | RMAD0 | 00h |
| 0011h | | | 00h |
| 0012h | | | 00h |
| 0013h | Address Match Interrupt Enable Register | AIER | 00h |
| 0014h | Address Match Interrupt Register 1 | RMAD1 | 00h |
| 0015h | | | 00h |
| 0016h | | | 00h |
| 0017h | | | |
| 0018h | | | |
| 0019h | | | |
| 001Ah | | | |
| 001Bh | | | |
| 001Ch | Count Source Protection Mode Register | CSPR | 00h 10000000b ⁽⁶⁾ |
| 001Dh | | | |
| 001Eh | | | |
| 001Fh | | | |
| 0020h | | | |
| 0021h | | | |
| 0022h | | | |
| 0023h | High-Speed On-Chip Oscillator Control Register 0 | FRA0 | 00h |
| 0024h | High-Speed On-Chip Oscillator Control Register 1 | FRA1 | When shipping |
| 0025h | High-Speed On-Chip Oscillator Control Register 2 | FRA2 | 00h |
| 0026h | | | |
| 0027h | | | |
| 0028h | Clock Prescaler Reset Flag | CPSRF | 00h |
| 0029h | High-Speed On-Chip Oscillator Control Register 4 | FRA4 | When shipping |
| 002Ah | | | |
| 002Bh | High-Speed On-Chip Oscillator Control Register 6 | FRA6 | When shipping |
| 002Ch | High-Speed On-Chip Oscillator Control Register 7 | FRA7 | When shipping |
| 0030h | | | |
| 0031h | Voltage Detection Register 1 ⁽²⁾ | VCA1 | 00001000b |
| 0032h | Voltage Detection Register 2 ⁽²⁾ | VCA2 | 00h ⁽³⁾ 00100000b ⁽⁴⁾ |
| 0033h | | | |
| 0034h | | | |
| 0035h | | | |
| 0036h | Voltage Monitor 1 Circuit Control Register ⁽⁵⁾ | VW1C | 00001000b |
| 0037h | Voltage Monitor 2 Circuit Control Register ⁽⁵⁾ | VW2C | 00h |
| 0038h | Voltage Monitor 0 Circuit Control Register ⁽²⁾ | VW0C | 0000X000b ⁽³⁾ 0100X001b ⁽⁴⁾ |
| 0039h | | | |
| 003Ah | | | |
| 003Eh | | | |
| 003Fh | | | |

X: Undefined

NOTES:

1. The blank regions are reserved. Do not access locations in these regions.
2. Software reset, watchdog timer reset, and voltage monitor 1 reset or voltage monitor 2 reset do not affect this register.
3. The LVDOON bit in the OFS register is set to 1 and hardware reset.
4. Power-on reset, voltage monitor 0 reset or the LVDOON bit in the OFS register is set to 0, and hardware reset.
5. Software reset, watchdog timer reset, and voltage monitor 1 reset or voltage monitor 2 reset do not affect b2 and b3.
6. The CSPROINI bit in the OFS register is set to 0.

Table 4.2 SFR Information (2)(1)

| Address | Register | Symbol | After reset |
|---------|---|---------------|-------------|
| 0040h | | | |
| 0041h | | | |
| 0042h | | | |
| 0043h | | | |
| 0044h | | | |
| 0045h | | | |
| 0046h | | | |
| 0047h | | | |
| 0048h | Timer RD0 Interrupt Control Register | TRD0IC | XXXXX000b |
| 0049h | Timer RD1 Interrupt Control Register | TRD1IC | XXXXX000b |
| 004Ah | Timer RE Interrupt Control Register | TREIC | XXXXX000b |
| 004Bh | | | |
| 004Ch | | | |
| 004Dh | Key Input Interrupt Control Register | KUPIC | XXXXX000b |
| 004Eh | A/D Conversion Interrupt Control Register | ADIC | XXXXX000b |
| 004Fh | SSU/IIC Interrupt Control Register(2) | SSUIC / IICIC | XXXXX000b |
| 0050h | | | |
| 0051h | UART0 Transmit Interrupt Control Register | S0TIC | XXXXX000b |
| 0052h | UART0 Receive Interrupt Control Register | S0RIC | XXXXX000b |
| 0053h | UART1 Transmit Interrupt Control Register | S1TIC | XXXXX000b |
| 0054h | UART1 Receive Interrupt Control Register | S1RIC | XXXXX000b |
| 0055h | INT2 Interrupt Control Register | INT2IC | XX00X000b |
| 0056h | Timer RA Interrupt Control Register | TRAIC | XXXXX000b |
| 0057h | | | |
| 0058h | Timer RB Interrupt Control Register | TRBIC | XXXXX000b |
| 0059h | INT1 Interrupt Control Register | INT1IC | XX00X000b |
| 005Ah | INT3 Interrupt Control Register | INT3IC | XX00X000b |
| 005Bh | | | |
| 005Ch | | | |
| 005Dh | INT0 Interrupt Control Register | INT0IC | XX00X000b |
| 005Eh | | | |
| 005Fh | | | |
| 0060h | | | |
| 0061h | | | |
| 0062h | | | |
| 0063h | | | |
| 0064h | | | |
| 0065h | | | |
| 0066h | | | |
| 0067h | | | |
| 0068h | | | |
| 0069h | | | |
| 006Ah | | | |
| 006Bh | | | |
| 006Ch | | | |
| 006Dh | | | |
| 006Eh | | | |
| 006Fh | | | |
| 0070h | | | |
| 0071h | | | |
| 0072h | | | |
| 0073h | | | |
| 0074h | | | |
| 0075h | | | |
| 0076h | | | |
| 0077h | | | |
| 0078h | | | |
| 0079h | | | |
| 007Ah | | | |
| 007Bh | | | |
| 007Ch | | | |
| 007Dh | | | |
| 007Eh | | | |
| 007Fh | | | |

X: Undefined

NOTES:

1. The blank regions are reserved. Do not access locations in these regions.
2. Selected by the IICSEL bit in the PMR register.

Table 4.3 SFR Information (3)(1)

| Address | Register | Symbol | After reset |
|---------|---|---------------|-----------------|
| 0080h | | | |
| 0081h | | | |
| 0082h | | | |
| 0083h | | | |
| 0084h | | | |
| 0085h | | | |
| 0086h | | | |
| 0087h | | | |
| 0088h | | | |
| 0089h | | | |
| 008Ah | | | |
| 008Bh | | | |
| 008Ch | | | |
| 008Dh | | | |
| 008Eh | | | |
| 008Fh | | | |
| 0090h | | | |
| 0091h | | | |
| 0092h | | | |
| 0093h | | | |
| 0094h | | | |
| 0095h | | | |
| 0096h | | | |
| 0097h | | | |
| 0098h | | | |
| 0099h | | | |
| 009Ah | | | |
| 009Bh | | | |
| 009Ch | | | |
| 009Dh | | | |
| 009Eh | | | |
| 009Fh | | | |
| 00A0h | UART0 Transmit/Receive Mode Register | U0MR | 00h |
| 00A1h | UART0 Bit Rate Register | U0BRG | XXh |
| 00A2h | UART0 Transmit Buffer Register | U0TB | XXh |
| 00A3h | | | XXh |
| 00A4h | UART0 Transmit/Receive Control Register 0 | U0C0 | 00001000b |
| 00A5h | UART0 Transmit/Receive Control Register 1 | U0C1 | 00000010b |
| 00A6h | UART0 Receive Buffer Register | U0RB | XXh |
| 00A7h | | | XXh |
| 00A8h | UART1 Transmit/Receive Mode Register | U1MR | 00h |
| 00A9h | UART1 Bit Rate Register | U1BRG | XXh |
| 00AAh | UART1 Transmit Buffer Register | U1TB | XXh |
| 00ABh | | | XXh |
| 00ACh | UART1 Transmit/Receive Control Register 0 | U1C0 | 00001000b |
| 00ADh | UART1 Transmit/Receive Control Register 1 | U1C1 | 00000010b |
| 00AEh | UART1 Receive Buffer Register | U1RB | XXh |
| 00AFh | | | XXh |
| 00B0h | | | |
| 00B1h | | | |
| 00B2h | | | |
| 00B3h | | | |
| 00B4h | | | |
| 00B5h | | | |
| 00B6h | | | |
| 00B7h | | | |
| 00B8h | SS Control Register H / IIC bus Control Register 1 ⁽²⁾ | SSCRH / ICCR1 | 00h |
| 00B9h | SS Control Register L / IIC bus Control Register 2 ⁽²⁾ | SSCRL / ICCR2 | 01111101b |
| 00BAh | SS Mode Register / IIC bus Mode Register ⁽²⁾ | SSMR / ICMR | 00011000b |
| 00BBh | SS Enable Register / IIC bus Interrupt Enable Register ⁽²⁾ | SSER / ICIER | 00h |
| 00BCh | SS Status Register / IIC bus Status Register ⁽²⁾ | SSSR / ICSR | 00h / 0000X000b |
| 00BDh | SS Mode Register 2 / Slave Address Register ⁽²⁾ | SSMR2 / SAR | 00h |
| 00BEh | SS Transmit Data Register / IIC bus Transmit Data Register ⁽²⁾ | SSTDR / ICDRT | FFh |
| 00BFh | SS Receive Data Register / IIC bus Receive Data Register ⁽²⁾ | SSRDR / ICDRR | FFh |

X: Undefined

NOTES:

1. The blank regions are reserved. Do not access locations in these regions.
2. Selected by the IICSEL bit in the PMR register.

Table 4.4 SFR Information (4)⁽¹⁾

| Address | Register | Symbol | After reset |
|---------|---|--------|-------------|
| 00C0h | A/D Register | AD | XXh |
| 00C1h | | | XXh |
| 00C2h | | | |
| 00C3h | | | |
| 00C4h | | | |
| 00C5h | | | |
| 00C6h | | | |
| 00C7h | | | |
| 00C8h | | | |
| 00C9h | | | |
| 00CAh | | | |
| 00CBh | | | |
| 00CCh | | | |
| 00CDh | | | |
| 00CEh | | | |
| 00CFh | | | |
| 00D0h | | | |
| 00D1h | | | |
| 00D2h | | | |
| 00D3h | | | |
| 00D4h | A/D Control Register 2 | ADCON2 | 00h |
| 00D5h | | | |
| 00D6h | A/D Control Register 0 | ADCON0 | 00h |
| 00D7h | A/D Control Register 1 | ADCON1 | 00h |
| 00D8h | | | |
| 00D9h | | | |
| 00DAh | | | |
| 00DBh | | | |
| 00DCh | | | |
| 00DDh | | | |
| 00DEh | | | |
| 00DFh | | | |
| 00E0h | Port P0 Register | P0 | XXh |
| 00E1h | Port P1 Register | P1 | XXh |
| 00E2h | Port P0 Direction Register | PD0 | 00h |
| 00E3h | Port P1 Direction Register | PD1 | 00h |
| 00E4h | Port P2 Register | P2 | XXh |
| 00E5h | Port P3 Register | P3 | XXh |
| 00E6h | Port P2 Direction Register | PD2 | 00h |
| 00E7h | Port P3 Direction Register | PD3 | 00h |
| 00E8h | Port P4 Register | P4 | XXh |
| 00E9h | | | |
| 00EAh | Port P4 Direction Register | PD4 | 00h |
| 00EBh | | | |
| 00ECh | Port P6 Register | P6 | XXh |
| 00EDh | | | |
| 00EEh | Port P6 Direction Register | PD6 | 00h |
| 00EFh | | | |
| 00F0h | | | |
| 00F1h | | | |
| 00F2h | | | |
| 00F3h | | | |
| 00F4h | Port P2 Drive Capacity Control Register | P2DRR | 00h |
| 00F5h | UART1 Function Select Register | U1SR | XXh |
| 00F6h | | | |
| 00F7h | | | |
| 00F8h | Port Mode Register | PMR | 00h |
| 00F9h | External Input Enable Register | INTEN | 00h |
| 00FAh | INT Input Filter Select Register | INTF | 00h |
| 00FBh | Key Input Enable Register | KIEN | 00h |
| 00FCh | Pull-Up Control Register 0 | PUR0 | 00h |
| 00FDh | Pull-Up Control Register 1 | PUR1 | XX00XX00b |
| 00FEh | | | |
| 00FFh | | | |

X: Undefined

NOTE:

1. The blank regions are reserved. Do not access locations in these regions.

Table 4.5 SFR Information (5)⁽¹⁾

| Address | Register | Symbol | After reset |
|---------|---|---------|-------------|
| 0100h | Timer RA Control Register | TRACR | 00h |
| 0101h | Timer RA I/O Control Register | TRAIOC | 00h |
| 0102h | Timer RA Mode Register | TRAMR | 00h |
| 0103h | Timer RA Prescaler Register | TRAPRE | FFh |
| 0104h | Timer RA Register | TRA | FFh |
| 0105h | | | |
| 0106h | LIN Control Register | LINCR | 00h |
| 0107h | LIN Status Register | LINST | 00h |
| 0108h | Timer RB Control Register | TRBCR | 00h |
| 0109h | Timer RB One-Shot Control Register | TRBOCR | 00h |
| 010Ah | Timer RB I/O Control Register | TRBIOC | 00h |
| 010Bh | Timer RB Mode Register | TRBMR | 00h |
| 010Ch | Timer RB Prescaler Register | TRBPRES | FFh |
| 010Dh | Timer RB Secondary Register | TRBSC | FFh |
| 010Eh | Timer RB Primary Register | TRBPR | FFh |
| 010Fh | | | |
| 0110h | | | |
| 0111h | | | |
| 0112h | | | |
| 0113h | | | |
| 0114h | | | |
| 0115h | | | |
| 0116h | | | |
| 0117h | | | |
| 0118h | Timer RE Second Data Register / Counter Data Register | TRESEC | 00h |
| 0119h | Timer RE Minute Data Register / Compare Data Register | TREMIN | 00h |
| 011Ah | Timer RE Hour Data Register | TREHR | 00h |
| 011Bh | Timer RE Day of Week Data Register | TREWK | 00h |
| 011Ch | Timer RE Control Register 1 | TRECR1 | 00h |
| 011Dh | Timer RE Control Register 2 | TRECR2 | 00h |
| 011Eh | Timer RE Count Source Select Register | TRECSR | 00001000b |
| 011Fh | | | |
| 0120h | | | |
| 0121h | | | |
| 0122h | | | |
| 0123h | | | |
| 0124h | | | |
| 0125h | | | |
| 0126h | | | |
| 0127h | | | |
| 0128h | | | |
| 0129h | | | |
| 012Ah | | | |
| 012Bh | | | |
| 012Ch | | | |
| 012Dh | | | |
| 012Eh | | | |
| 012Fh | | | |
| 0130h | | | |
| 0131h | | | |
| 0132h | | | |
| 0133h | | | |
| 0134h | | | |
| 0135h | | | |
| 0136h | | | |
| 0137h | Timer RD Start Register | TRDSTR | 11111100b |
| 0138h | Timer RD Mode Register | TRDMR | 00001110b |
| 0139h | Timer RD PWM Mode Register | TRDPMR | 10001000b |
| 013Ah | Timer RD Function Control Register | TRDFCR | 10000000b |
| 013Bh | Timer RD Output Master Enable Register 1 | TRDOER1 | FFh |
| 013Ch | Timer RD Output Master Enable Register 2 | TRDOER2 | 01111111b |
| 013Dh | Timer RD Output Control Register | TRDOCR | 00h |
| 013Eh | Timer RD Digital Filter Function Select Register 0 | TRDDF0 | 00h |
| 013Fh | Timer RD Digital Filter Function Select Register 1 | TRDDF1 | 00h |

X: Undefined

NOTE:

1. The blank regions are reserved. Do not access locations in these regions.

Table 4.6 SFR Information (6)⁽¹⁾

| Address | Register | Symbol | After reset |
|---------|---|----------|-------------|
| 0140h | Timer RD Control Register 0 | TRDCR0 | 00h |
| 0141h | Timer RD I/O Control Register A0 | TRDIORA0 | 10001000b |
| 0142h | Timer RD I/O Control Register C0 | TRDIORC0 | 10001000b |
| 0143h | Timer RD Status Register 0 | TRDSR0 | 11100000b |
| 0144h | Timer RD Interrupt Enable Register 0 | TRDIER0 | 11100000b |
| 0145h | Timer RD PWM Mode Output Level Control Register 0 | TRDPOCR0 | 11111000b |
| 0146h | Timer RD Counter 0 | TRD0 | 00h |
| 0147h | | | 00h |
| 0148h | Timer RD General Register A0 | TRDGRA0 | FFh |
| 0149h | | | FFh |
| 014Ah | Timer RD General Register B0 | TRDGRB0 | FFh |
| 014Bh | | | FFh |
| 014Ch | Timer RD General Register C0 | TRDGRC0 | FFh |
| 014Dh | | | FFh |
| 014Eh | Timer RD General Register D0 | TRDGRD0 | FFh |
| 014Fh | | | FFh |
| 0150h | Timer RD Control Register 1 | TRDCR1 | 00h |
| 0151h | Timer RD I/O Control Register A1 | TRDIORA1 | 10001000b |
| 0152h | Timer RD I/O Control Register C1 | TRDIORC1 | 10001000b |
| 0153h | Timer RD Status Register 1 | TRDSR1 | 11000000b |
| 0154h | Timer RD Interrupt Enable Register 1 | TRDIER1 | 11100000b |
| 0155h | Timer RD PWM Mode Output Level Control Register 1 | TRDPOCR1 | 11111000b |
| 0156h | Timer RD Counter 1 | TRD1 | 00h |
| 0157h | | | 00h |
| 0158h | Timer RD General Register A1 | TRDGRA1 | FFh |
| 0159h | | | FFh |
| 015Ah | Timer RD General Register B1 | TRDGRB1 | FFh |
| 015Bh | | | FFh |
| 015Ch | Timer RD General Register C1 | TRDGRC1 | FFh |
| 015Dh | | | FFh |
| 015Eh | Timer RD General Register D1 | TRDGRD1 | FFh |
| 015Fh | | | FFh |
| 0160h | | | |
| 0161h | | | |
| 0162h | | | |
| 0163h | | | |
| 0164h | | | |
| 0165h | | | |
| 0166h | | | |
| 0167h | | | |
| 0168h | | | |
| 0169h | | | |
| 016Ah | | | |
| 016Bh | | | |
| 016Ch | | | |
| 016Dh | | | |
| 016Eh | | | |
| 016Fh | | | |
| 0170h | | | |
| 0171h | | | |
| 0172h | | | |
| 0173h | | | |
| 0174h | | | |
| 0175h | | | |
| 0176h | | | |
| 0177h | | | |
| 0178h | | | |
| 0179h | | | |
| 017Ah | | | |
| 017Bh | | | |
| 017Ch | | | |
| 017Dh | | | |
| 017Eh | | | |
| 017Fh | | | |

X: Undefined

NOTE:

1. The blank regions are reserved. Do not access locations in these regions.

Table 4.7 SFR Information (7)(1)

| Address | Register | Symbol | After reset |
|---------|---------------------------------|--------|-------------|
| 0180h | | | |
| 0181h | | | |
| 0182h | | | |
| 0183h | | | |
| 0184h | | | |
| 0185h | | | |
| 0186h | | | |
| 0187h | | | |
| 0188h | | | |
| 0189h | | | |
| 018Ah | | | |
| 018Bh | | | |
| 018Ch | | | |
| 018Dh | | | |
| 018Eh | | | |
| 018Fh | | | |
| 0190h | | | |
| 0191h | | | |
| 0192h | | | |
| 0193h | | | |
| 0194h | | | |
| 0195h | | | |
| 0196h | | | |
| 0197h | | | |
| 0198h | | | |
| 0199h | | | |
| 019Ah | | | |
| 019Bh | | | |
| 019Ch | | | |
| 019Dh | | | |
| 019Eh | | | |
| 019Fh | | | |
| 01A0h | | | |
| 01A1h | | | |
| 01A2h | | | |
| 01A3h | | | |
| 01A4h | | | |
| 01A5h | | | |
| 01A6h | | | |
| 01A7h | | | |
| 01A8h | | | |
| 01A9h | | | |
| 01AAh | | | |
| 01ABh | | | |
| 01ACh | | | |
| 01ADh | | | |
| 01AEh | | | |
| 01AFh | | | |
| 01B0h | | | |
| 01B1h | | | |
| 01B2h | | | |
| 01B3h | Flash Memory Control Register 4 | FMR4 | 01000000b |
| 01B4h | | | |
| 01B5h | Flash Memory Control Register 1 | FMR1 | 1000000Xb |
| 01B6h | | | |
| 01B7h | Flash Memory Control Register 0 | FMR0 | 00000001b |
| 01B8h | | | |
| 01B9h | | | |
| 01BAh | | | |
| 01BBh | | | |
| 01BCh | | | |
| 01BDh | | | |
| 01BEh | | | |
| 01BFh | | | |
| FFFFh | Option Function Select Register | OFS | (Note 2) |

X: Undefined

NOTES:

1. The blank regions are reserved. Do not access locations in these regions.
2. The OFS register cannot be changed by a program. Use a flash programmer to write to it.

5. Electrical Characteristics

The electrical characteristics of N version ($T_{opr} = -20$ to 85°C) and D version ($T_{opr} = -40$ to 85°C) are listed below.

Please contact Renesas Technology sales offices for the electrical characteristics in the Y version ($T_{opr} = -20$ to 105°C).

Table 5.1 Absolute Maximum Ratings

| Symbol | Parameter | Condition | Rated Value | Unit |
|------------------|-------------------------------|--------------------------------|--|--------------------|
| V_{cc}/AV_{cc} | Supply voltage | | -0.3 to 6.5 | V |
| V_i | Input voltage | | -0.3 to $V_{cc} + 0.3$ | V |
| V_o | Output voltage | | -0.3 to $V_{cc} + 0.3$ | V |
| P_d | Power dissipation | $T_{opr} = 25^{\circ}\text{C}$ | 500 ⁽¹⁾ | mW |
| T_{opr} | Operating ambient temperature | | -20 to 85 (N version) / -40 to 85 (D version) | $^{\circ}\text{C}$ |
| T_{stg} | Storage temperature | | -65 to 150 | $^{\circ}\text{C}$ |

NOTE:

1. 300 mW for the PTLG0064JA-A package.

Table 5.2 Recommended Operating Conditions

| Symbol | Parameter | | Conditions | Standard | | | Unit | | |
|-----------------------------------|--|--|--|---|---------------------------------|---------------------|------|-----|-----|
| | | | | Min. | Typ. | Max. | | | |
| V _{CC} /AV _{CC} | Supply voltage | | | 2.2 | – | 5.5 | V | | |
| V _{SS} /AV _{SS} | Supply voltage | | | – | 0 | – | V | | |
| V _{IH} | Input “H” voltage | | | 0.8 V _{CC} | – | V _{CC} | V | | |
| V _{IL} | Input “L” voltage | | | 0 | – | 0.2 V _{CC} | V | | |
| I _{OH} (sum) | Peak sum output “H” current | Sum of all pins I _{OH} (peak) | | – | – | -160 | mA | | |
| I _{OH} (sum) | Average sum output “H” current | Sum of all pins I _{OH} (avg) | | – | – | -80 | mA | | |
| I _{OH} (peak) | Peak output “H” current | Except P2_0 to P2_7 | | – | – | -10 | mA | | |
| | | P2_0 to P2_7 | | – | – | -40 | mA | | |
| I _{OH} (avg) | Average output “H” current | Except P2_0 to P2_7 | | – | – | -5 | mA | | |
| | | P2_0 to P2_7 | | – | – | -20 | mA | | |
| I _{OL} (sum) | Peak sum output “L” current | Sum of all pins I _{OL} (peak) | | – | – | 160 | mA | | |
| I _{OL} (sum) | Average sum output “L” current | Sum of all pins I _{OL} (avg) | | – | – | 80 | mA | | |
| I _{OL} (peak) | Peak output “L” current | Except P2_0 to P2_7 | | – | – | 10 | mA | | |
| | | P2_0 to P2_7 | | – | – | 40 | mA | | |
| I _{OL} (avg) | Average output “L” current | Except P2_0 to P2_7 | | – | – | 5 | mA | | |
| | | P2_0 to P2_7 | | – | – | 20 | mA | | |
| f(XIN) | XIN clock input oscillation frequency | | 3.0 V ≤ V _{CC} ≤ 5.5 V | 0 | – | 20 | MHz | | |
| | | | 2.7 V ≤ V _{CC} < 3.0 V | 0 | – | 10 | MHz | | |
| | | | 2.2 V ≤ V _{CC} < 2.7 V | 0 | – | 5 | MHz | | |
| f(XCIN) | XCIN clock input oscillation frequency | | 2.2 V ≤ V _{CC} ≤ 5.5 V | 0 | – | 70 | kHz | | |
| – | System clock | OCD2 = 0 XIN clock selected | 3.0 V ≤ V _{CC} ≤ 5.5 V | 0 | – | 20 | MHz | | |
| | | | 2.7 V ≤ V _{CC} < 3.0 V | 0 | – | 10 | MHz | | |
| | | | 2.2 V ≤ V _{CC} < 2.7 V | 0 | – | 5 | MHz | | |
| | On-chip oscillator clock selected | OCD2 = 1 | FRA01 = 0 Low-speed on-chip oscillator clock selected | – | – | 125 | – | kHz | |
| | | | | FRA01 = 1 High-speed on-chip oscillator clock selected | 3.0 V ≤ V _{CC} ≤ 5.5 V | – | – | 20 | MHz |
| | | | | | 2.7 V ≤ V _{CC} ≤ 5.5 V | – | – | 10 | MHz |
| | | | | | 2.2 V ≤ V _{CC} ≤ 5.5 V | – | – | 5 | MHz |

NOTES:

- V_{CC} = 2.2 to 5.5 V at T_{opr} = -20 to 85°C (N version) / -40 to 85°C (D version), unless otherwise specified.
- The average output current indicates the average value of current measured during 100 ms.

Table 5.3 A/D Converter Characteristics

| Symbol | Parameter | | Conditions | Standard | | | Unit |
|--------------|-------------------------------------|-------------------------|---|----------|------|-----------|---------------|
| | | | | Min. | Typ. | Max. | |
| – | Resolution | | $V_{ref} = AV_{CC}$ | – | – | 10 | Bit |
| – | Absolute accuracy | 10-bit mode | $\phi_{AD} = 10 \text{ MHz}, V_{ref} = AV_{CC} = 5.0 \text{ V}$ | – | – | ± 3 | LSB |
| | | 8-bit mode | $\phi_{AD} = 10 \text{ MHz}, V_{ref} = AV_{CC} = 5.0 \text{ V}$ | – | – | ± 2 | LSB |
| | | 10-bit mode | $\phi_{AD} = 10 \text{ MHz}, V_{ref} = AV_{CC} = 3.3 \text{ V}$ | – | – | ± 5 | LSB |
| | | 8-bit mode | $\phi_{AD} = 10 \text{ MHz}, V_{ref} = AV_{CC} = 3.3 \text{ V}$ | – | – | ± 2 | LSB |
| | | 10-bit mode | $\phi_{AD} = 5 \text{ MHz}, V_{ref} = AV_{CC} = 2.2 \text{ V}$ | – | – | ± 5 | LSB |
| | | 8-bit mode | $\phi_{AD} = 5 \text{ MHz}, V_{ref} = AV_{CC} = 2.2 \text{ V}$ | – | – | ± 2 | LSB |
| R_{ladder} | Resistor ladder | | $V_{ref} = AV_{CC}$ | 10 | – | 40 | $k\Omega$ |
| t_{conv} | Conversion time | 10-bit mode | $\phi_{AD} = 10 \text{ MHz}, V_{ref} = AV_{CC} = 5.0 \text{ V}$ | 3.3 | – | – | μs |
| | | 8-bit mode | $\phi_{AD} = 10 \text{ MHz}, V_{ref} = AV_{CC} = 5.0 \text{ V}$ | 2.8 | – | – | μs |
| V_{ref} | Reference voltage | | | 2.2 | – | AV_{CC} | V |
| V_{IA} | Analog input voltage ⁽²⁾ | | | 0 | – | AV_{CC} | V |
| – | A/D operating clock frequency | Without sample and hold | $V_{ref} = AV_{CC} = 2.7 \text{ to } 5.5 \text{ V}$ | 0.25 | – | 10 | MHz |
| | | With sample and hold | $V_{ref} = AV_{CC} = 2.7 \text{ to } 5.5 \text{ V}$ | 1 | – | 10 | MHz |
| | | Without sample and hold | $V_{ref} = AV_{CC} = 2.2 \text{ to } 5.5 \text{ V}$ | 0.25 | – | 5 | MHz |
| | | With sample and hold | $V_{ref} = AV_{CC} = 2.2 \text{ to } 5.5 \text{ V}$ | 1 | – | 5 | MHz |

NOTES:

1. $AV_{CC} = 2.2 \text{ to } 5.5 \text{ V}$ at $T_{opr} = -20 \text{ to } 85^\circ\text{C}$ (N version) / $-40 \text{ to } 85^\circ\text{C}$ (D version), unless otherwise specified.
2. When the analog input voltage is over the reference voltage, the A/D conversion result will be 3FFh in 10-bit mode and FFh in 8-bit mode.

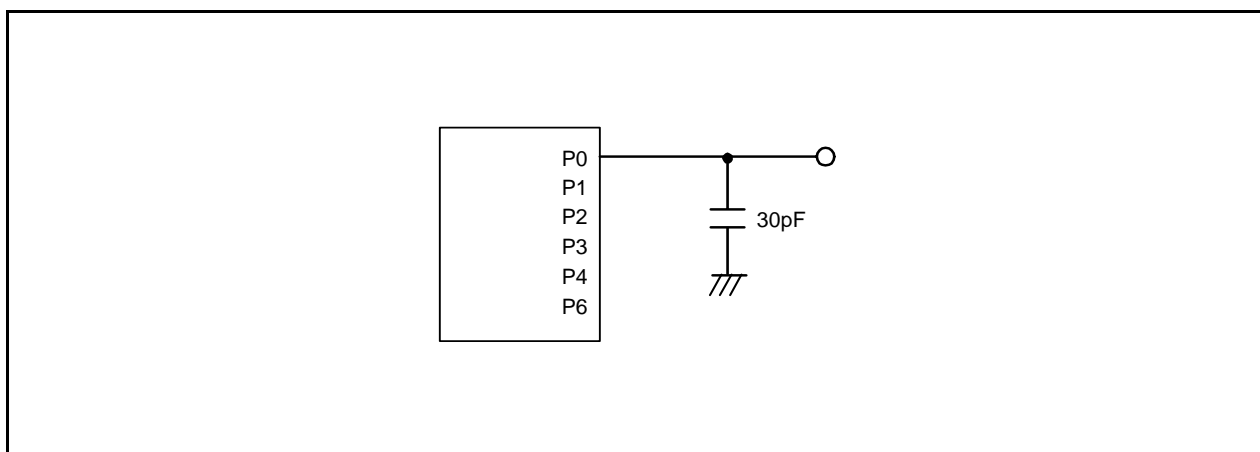
**Figure 5.1 Ports P0 to P4, P6 Timing Measurement Circuit**

Table 5.4 Flash Memory (Program ROM) Electrical Characteristics

| Symbol | Parameter | Conditions | Standard | | | Unit |
|-------------------------|---|----------------------------|----------------------|------|----------------------------|-------|
| | | | Min. | Typ. | Max. | |
| – | Program/erase endurance ⁽²⁾ | R8C/24 Group | 100 ⁽³⁾ | – | – | times |
| | | R8C/25 Group | 1,000 ⁽³⁾ | – | – | times |
| – | Byte program time | | – | 50 | 400 | μs |
| – | Block erase time | | – | 0.4 | 9 | s |
| t _d (SR-SUS) | Time delay from suspend request until suspend | | – | – | 97+CPU clock × 6 cycles | μs |
| – | Interval from erase start/restart until following suspend request | | 650 | – | – | μs |
| – | Interval from program start/restart until following suspend request | | 0 | – | – | ns |
| – | Time from suspend until program/erase restart | | – | – | 3+CPU clock × 4 cycles | μs |
| – | Program, erase voltage | | 2.7 | – | 5.5 | V |
| – | Read voltage | | 2.2 | – | 5.5 | V |
| – | Program, erase temperature | | 0 | – | 60 | °C |
| – | Data hold time ⁽⁷⁾ | Ambient temperature = 55°C | 20 | – | – | year |

NOTES:

1. V_{CC} = 2.7 to 5.5 V at T_{opr} = 0 to 60°C, unless otherwise specified.
2. Definition of programming/erasure endurance
The programming and erasure endurance is defined on a per-block basis.
If the programming and erasure endurance is n (n = 100 or 10,000), each block can be erased n times. For example, if 1,024 1-byte writes are performed to block A, a 1 Kbyte block, and then the block is erased, the programming/erasure endurance still stands at one.
However, the same address must not be programmed more than once per erase operation (overwriting prohibited).
3. Endurance to guarantee all electrical characteristics after program and erase. (1 to Min. value can be guaranteed).
4. In a system that executes multiple programming operations, the actual erasure count can be reduced by writing to sequential addresses in turn so that as much of the block as possible is used up before performing an erase operation. For example, when programming groups of 16 bytes, the effective number of rewrites can be minimized by programming up to 128 groups before erasing them all in one operation. It is also advisable to retain data on the erase count of each block and limit the number of erase operations to a certain number.
5. If an error occurs during block erase, attempt to execute the clear status register command, then execute the block erase command at least three times until the erase error does not occur.
6. Customers desiring program/erase failure rate information should contact their Renesas technical support representative.
7. The data hold time includes time that the power supply is off or the clock is not supplied.

Table 5.5 Flash Memory (Data flash Block A, Block B) Electrical Characteristics⁽⁴⁾

| Symbol | Parameter | Conditions | Standard | | | Unit |
|-------------------------|---|-----------------------------|-----------------------|------|----------------------------|-------|
| | | | Min. | Typ. | Max. | |
| – | Program/erase endurance ⁽²⁾ | | 10,000 ⁽³⁾ | – | – | times |
| – | Byte program time (program/erase endurance ≤ 1,000 times) | | – | 50 | 400 | μs |
| – | Byte program time (program/erase endurance > 1,000 times) | | – | 65 | – | μs |
| – | Block erase time (program/erase endurance ≤ 1,000 times) | | – | 0.2 | 9 | s |
| – | Block erase time (program/erase endurance > 1,000 times) | | – | 0.3 | – | s |
| t _d (SR-SUS) | Time delay from suspend request until suspend | | – | – | 97+CPU clock × 6 cycles | μs |
| – | Interval from erase start/restart until following suspend request | | 650 | – | – | μs |
| – | Interval from program start/restart until following suspend request | | 0 | – | – | ns |
| – | Time from suspend until program/erase restart | | – | – | 3+CPU clock × 4 cycles | μs |
| – | Program, erase voltage | | 2.7 | – | 5.5 | V |
| – | Read voltage | | 2.2 | – | 5.5 | V |
| – | Program, erase temperature | | -20 ⁽⁸⁾ | – | 85 | °C |
| – | Data hold time ⁽⁹⁾ | Ambient temperature = 55 °C | 20 | – | – | year |

NOTES:

- V_{CC} = 2.7 to 5.5 V at T_{opr} = -20 to 85°C (N version) / -40 to 85°C (D version), unless otherwise specified.
- Definition of programming/erasure endurance
The programming and erasure endurance is defined on a per-block basis.
If the programming and erasure endurance is n (n = 100 or 10,000), each block can be erased n times. For example, if 1,024 1-byte writes are performed to block A, a 1 Kbyte block, and then the block is erased, the programming/erasure endurance still stands at one.
However, the same address must not be programmed more than once per erase operation (overwriting prohibited).
- Endurance to guarantee all electrical characteristics after program and erase. (1 to Min. value can be guaranteed).
- Standard of block A and block B when program and erase endurance exceeds 1,000 times. Byte program time to 1,000 times is the same as that in program ROM.
- In a system that executes multiple programming operations, the actual erasure count can be reduced by writing to sequential addresses in turn so that as much of the block as possible is used up before performing an erase operation. For example, when programming groups of 16 bytes, the effective number of rewrites can be minimized by programming up to 128 groups before erasing them all in one operation. It is also advisable to retain data on the erase count of each block and limit the number of erase operations to a certain number.
- If an error occurs during block erase, attempt to execute the clear status register command, then execute the block erase command at least three times until the erase error does not occur.
- Customers desiring program/erase failure rate information should contact their Renesas technical support representative.
- 40°C for D version.
- The data hold time includes time that the power supply is off or the clock is not supplied.

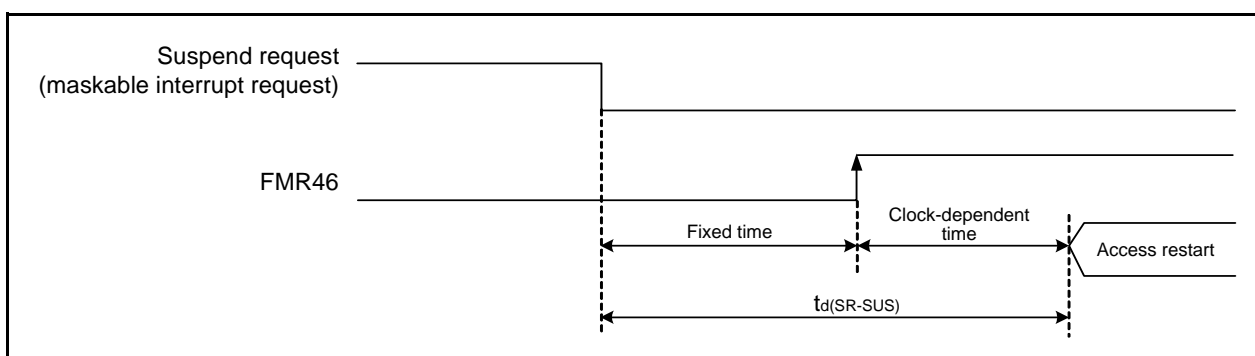


Figure 5.2 Time delay until Suspend

Table 5.6 Voltage Detection 0 Circuit Electrical Characteristics

| Symbol | Parameter | Condition | Standard | | | Unit |
|---------------------|--|------------------------------------|----------|------|------|------|
| | | | Min. | Typ. | Max. | |
| V _{det0} | Voltage detection level | | 2.2 | 2.3 | 2.4 | V |
| – | Voltage detection circuit self power consumption | VCA25 = 1, V _{CC} = 5.0 V | – | 0.9 | – | μA |
| t _{d(E-A)} | Waiting time until voltage detection circuit operation starts ⁽²⁾ | | – | – | 300 | μs |
| V _{ccmin} | MCU operating voltage minimum value | | 2.2 | – | – | V |

NOTES:

1. The measurement condition is V_{CC} = 2.2 to 5.5 V and T_{opr} = -20 to 85°C (N version) / -40 to 85°C (D version).
2. Necessary time until the voltage detection circuit operates when setting to 1 again after setting the VCA25 bit in the VCA2 register to 0.

Table 5.7 Voltage Detection 1 Circuit Electrical Characteristics

| Symbol | Parameter | Condition | Standard | | | Unit |
|---------------------|--|------------------------------------|----------|------|------|------|
| | | | Min. | Typ. | Max. | |
| V _{det1} | Voltage detection level | | 2.70 | 2.85 | 3.00 | V |
| – | Voltage monitor 1 interrupt request generation time ⁽²⁾ | | – | 40 | – | μs |
| – | Voltage detection circuit self power consumption | VCA26 = 1, V _{CC} = 5.0 V | – | 0.6 | – | μA |
| t _{d(E-A)} | Waiting time until voltage detection circuit operation starts ⁽³⁾ | | – | – | 100 | μs |

NOTES:

1. The measurement condition is V_{CC} = 2.2 to 5.5 V and T_{opr} = -20 to 85°C (N version) / -40 to 85°C (D version).
2. Time until the voltage monitor 1 interrupt request is generated after the voltage passes V_{det1}.
3. Necessary time until the voltage detection circuit operates when setting to 1 again after setting the VCA26 bit in the VCA2 register to 0.

Table 5.8 Voltage Detection 2 Circuit Electrical Characteristics

| Symbol | Parameter | Condition | Standard | | | Unit |
|---------------------|--|------------------------------------|----------|------|------|------|
| | | | Min. | Typ. | Max. | |
| V _{det2} | Voltage detection level | | 3.3 | 3.6 | 3.9 | V |
| – | Voltage monitor 2 interrupt request generation time ⁽²⁾ | | – | 40 | – | μs |
| – | Voltage detection circuit self power consumption | VCA27 = 1, V _{CC} = 5.0 V | – | 0.6 | – | μA |
| t _{d(E-A)} | Waiting time until voltage detection circuit operation starts ⁽³⁾ | | – | – | 100 | μs |

NOTES:

1. The measurement condition is V_{CC} = 2.2 to 5.5 V and T_{opr} = -20 to 85°C (N version) / -40 to 85°C (D version).
2. Time until the voltage monitor 2 interrupt request is generated after the voltage passes V_{det2}.
3. Necessary time until the voltage detection circuit operates after setting to 1 again after setting the VCA27 bit in the VCA2 register to 0.

Table 5.9 Power-on Reset Circuit, Voltage Monitor 0 Reset Electrical Characteristics⁽³⁾

| Symbol | Parameter | Condition | Standard | | | Unit |
|-------------------|---|-----------|----------|------|-------------------|---------|
| | | | Min. | Typ. | Max. | |
| V _{por1} | Power-on reset valid voltage ⁽⁴⁾ | | – | – | 0.1 | V |
| V _{por2} | Power-on reset or voltage monitor 0 reset valid voltage | | 0 | – | V _{det0} | V |
| t _{trth} | External power V _{cc} rise gradient ⁽²⁾ | | 20 | – | – | mV/msec |

NOTES:

1. The measurement condition is T_{opr} = -20 to 85°C (N version) / -40 to 85°C (D version), unless otherwise specified.
2. This condition (external power V_{cc} rise gradient) does not apply if V_{cc} ≥ 1.0 V.
3. To use the power-on reset function, enable voltage monitor 0 reset by setting the LVD00N bit in the OFS register to 0, the VW0C0 and VW0C6 bits in the VW0C register to 1 respectively, and the VCA25 bit in the VCA2 register to 1.
4. t_{w(por1)} indicates the duration the external power V_{cc} must be held below the effective voltage (V_{por1}) to enable a power on reset. When turning on the power for the first time, maintain t_{w(por1)} for 30 s or more if -20°C ≤ T_{opr} ≤ 85°C, maintain t_{w(por1)} for 3,000 s or more if -40°C ≤ T_{opr} < -20°C.

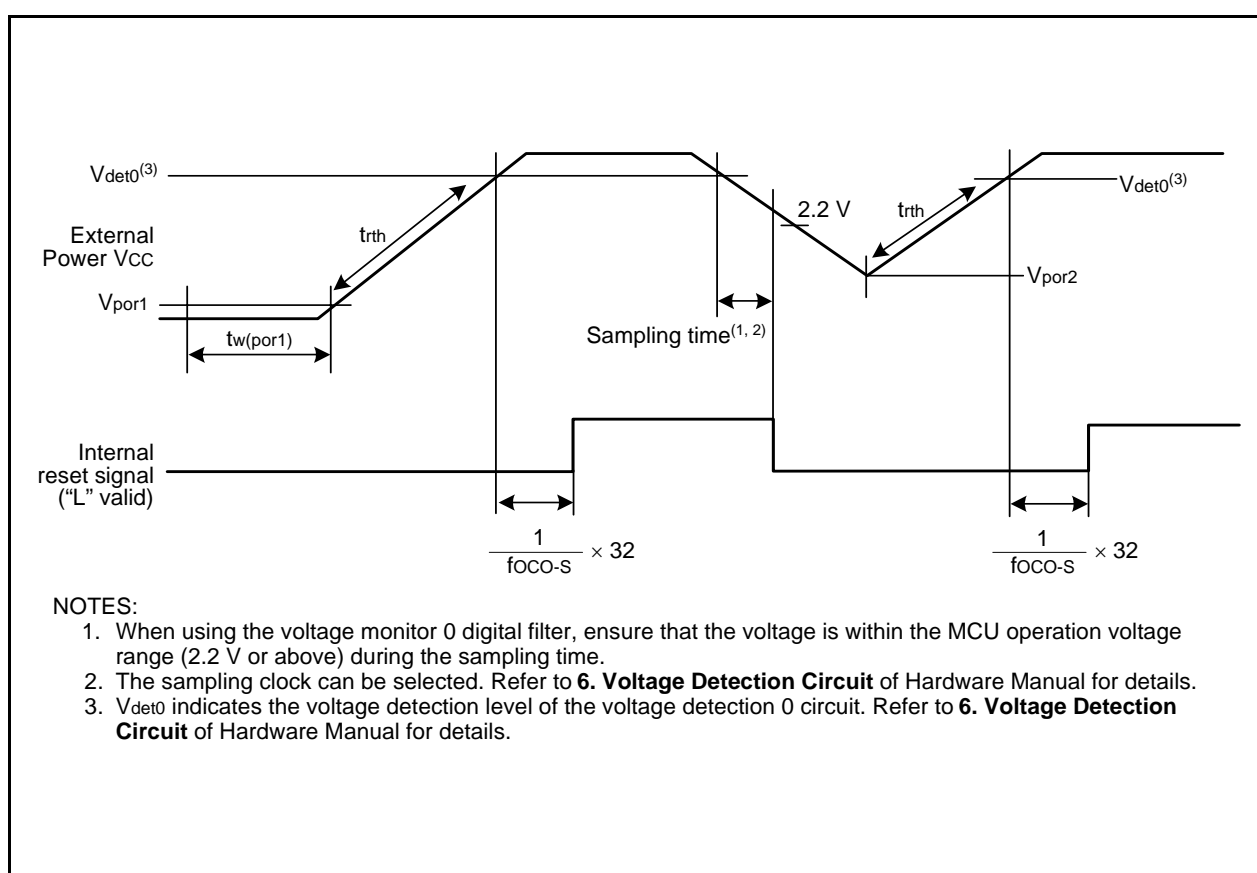
**Figure 5.3 Power-on Reset Circuit Electrical Characteristics**

Table 5.10 High-speed On-Chip Oscillator Circuit Electrical Characteristics

| Symbol | Parameter | Condition | Standard | | | Unit |
|---|---|---|--|------|--------|------|
| | | | Min. | Typ. | Max. | |
| fOCO40M | High-speed on-chip oscillator frequency temperature • supply voltage dependence | V _{CC} = 4.75 to 5.25 V 0°C ≤ T _{opr} ≤ 60°C ⁽²⁾ | 39.2 | 40 | 40.8 | MHz |
| | | V _{CC} = 4.5 to 5.5 V -20°C ≤ T _{opr} ≤ 85°C | 38.8 | 40 | 40.8 | MHz |
| | | V _{CC} = 4.5 to 5.5 V -40°C ≤ T _{opr} ≤ 85°C | 38.4 | 40 | 40.8 | MHz |
| | | V _{CC} = 3.0 to 5.5 V -20°C ≤ T _{opr} ≤ 85°C ⁽²⁾ | 38.8 | 40 | 41.2 | MHz |
| | | V _{CC} = 3.0 to 5.5 V -40°C ≤ T _{opr} ≤ 85°C ⁽²⁾ | 38.4 | 40 | 41.6 | MHz |
| | | V _{CC} = 2.7 to 5.5 V -20°C ≤ T _{opr} ≤ 85°C ⁽²⁾ | 38 | 40 | 42 | MHz |
| | | V _{CC} = 2.7 to 5.5 V -40°C ≤ T _{opr} ≤ 85°C ⁽²⁾ | 37.6 | 40 | 42.4 | MHz |
| | | V _{CC} = 2.2 to 5.5 V -20°C ≤ T _{opr} ≤ 85°C ⁽³⁾ | 35.2 | 40 | 44.8 | MHz |
| | | V _{CC} = 2.2 to 5.5 V -40°C ≤ T _{opr} ≤ 85°C ⁽³⁾ | 34 | 40 | 46 | MHz |
| | | High-speed on-chip oscillator frequency when correction value in FRA7 register is written to FRA1 register ⁽⁴⁾ | V _{CC} = 5.0 V, T _{opr} = 25°C | – | 36.864 | – |
| V _{CC} = 3.0 to 5.5 V -20°C ≤ T _{opr} ≤ 85°C | -3% | | – | 3% | % | |
| – | Value in FRA1 register after reset | | 08h | – | F7h | – |
| – | Oscillation frequency adjustment unit of high-speed on-chip oscillator | Adjust FRA1 register (value after reset) to -1 | – | +0.3 | – | MHz |
| – | Oscillation stability time | | – | 10 | 100 | μs |
| – | Self power consumption at oscillation | V _{CC} = 5.0 V, T _{opr} = 25°C | – | 400 | – | μA |

NOTES:

- V_{CC} = 2.2 to 5.5 V, T_{opr} = -20 to 85°C (N version) / -40 to 85°C (D version), unless otherwise specified.
- Standard values when the FRA1 register value after reset is assumed.
- Standard values when the corrected value of the FRA6 register has been written to the FRA1 register.
- This enables the setting errors of bit rates such as 9600 bps and 38400 bps to be 0% when the serial interface is used in UART mode.

Table 5.11 Low-speed On-Chip Oscillator Circuit Electrical Characteristics

| Symbol | Parameter | Condition | Standard | | | Unit |
|--------|--|--|----------|------|------|------|
| | | | Min. | Typ. | Max. | |
| fOCO-S | Low-speed on-chip oscillator frequency | | 30 | 125 | 250 | kHz |
| – | Oscillation stability time | | – | 10 | 100 | μs |
| – | Self power consumption at oscillation | V _{CC} = 5.0 V, T _{opr} = 25°C | – | 15 | – | μA |

NOTE:

- V_{CC} = 2.2 to 5.5 V, T_{opr} = -20 to 85°C (N version) / -40 to 85°C (D version), unless otherwise specified.

Table 5.12 Power Supply Circuit Timing Characteristics

| Symbol | Parameter | Condition | Standard | | | Unit |
|----------------------|---|-----------|----------|------|------|------|
| | | | Min. | Typ. | Max. | |
| t _d (P-R) | Time for internal power supply stabilization during power-on ⁽²⁾ | | 1 | – | 2000 | μs |
| t _d (R-S) | STOP exit time ⁽³⁾ | | – | – | 150 | μs |

NOTES:

- The measurement condition is V_{CC} = 2.2 to 5.5 V and T_{opr} = 25°C.
- Waiting time until the internal power supply generation circuit stabilizes during power-on.
- Time until system clock supply starts after the interrupt is acknowledged to exit stop mode.

Table 5.13 Timing Requirements of Clock Synchronous Serial I/O with Chip Select⁽¹⁾

| Symbol | Parameter | | Conditions | Standard | | | Unit |
|--------|------------------------------------|--------|---|------------|------|------------------------|---------------------|
| | | | | Min. | Typ. | Max. | |
| tsucyc | SSCK clock cycle time | | | 4 | – | – | tcyc ⁽²⁾ |
| tHI | SSCK clock "H" width | | | 0.4 | – | 0.6 | tsucyc |
| tLO | SSCK clock "L" width | | | 0.4 | – | 0.6 | tsucyc |
| tRISE | SSCK clock rising time | Master | | – | – | 1 | tcyc ⁽²⁾ |
| | | Slave | | – | – | 1 | μs |
| tFALL | SSCK clock falling time | Master | | – | – | 1 | tcyc ⁽²⁾ |
| | | Slave | | – | – | 1 | μs |
| tsu | SSO, SSI data input setup time | | | 100 | – | – | ns |
| tH | SSO, SSI data input hold time | | | 1 | – | – | tcyc ⁽²⁾ |
| tLEAD | $\overline{\text{SCS}}$ setup time | Slave | | 1tcyc + 50 | – | – | ns |
| tLAG | $\overline{\text{SCS}}$ hold time | Slave | | 1tcyc + 50 | – | – | ns |
| tOD | SSO, SSI data output delay time | | | – | – | 1 | tcyc ⁽²⁾ |
| tSA | SSI slave access time | | $2.7 \text{ V} \leq V_{\text{CC}} \leq 5.5 \text{ V}$ | – | – | $1.5\text{tcyc} + 100$ | ns |
| | | | $2.2 \text{ V} \leq V_{\text{CC}} < 2.7 \text{ V}$ | – | – | $1.5\text{tcyc} + 200$ | ns |
| tOR | SSI slave out open time | | $2.7 \text{ V} \leq V_{\text{CC}} \leq 5.5 \text{ V}$ | – | – | $1.5\text{tcyc} + 100$ | ns |
| | | | $2.2 \text{ V} \leq V_{\text{CC}} < 2.7 \text{ V}$ | – | – | $1.5\text{tcyc} + 200$ | ns |

NOTES:

1. $V_{\text{CC}} = 2.2$ to 5.5 V , $V_{\text{SS}} = 0 \text{ V}$ at $T_{\text{opr}} = -20$ to 85°C (N version) / -40 to 85°C (D version), unless otherwise specified.
2. $1\text{tcyc} = 1/f_1(\text{s})$

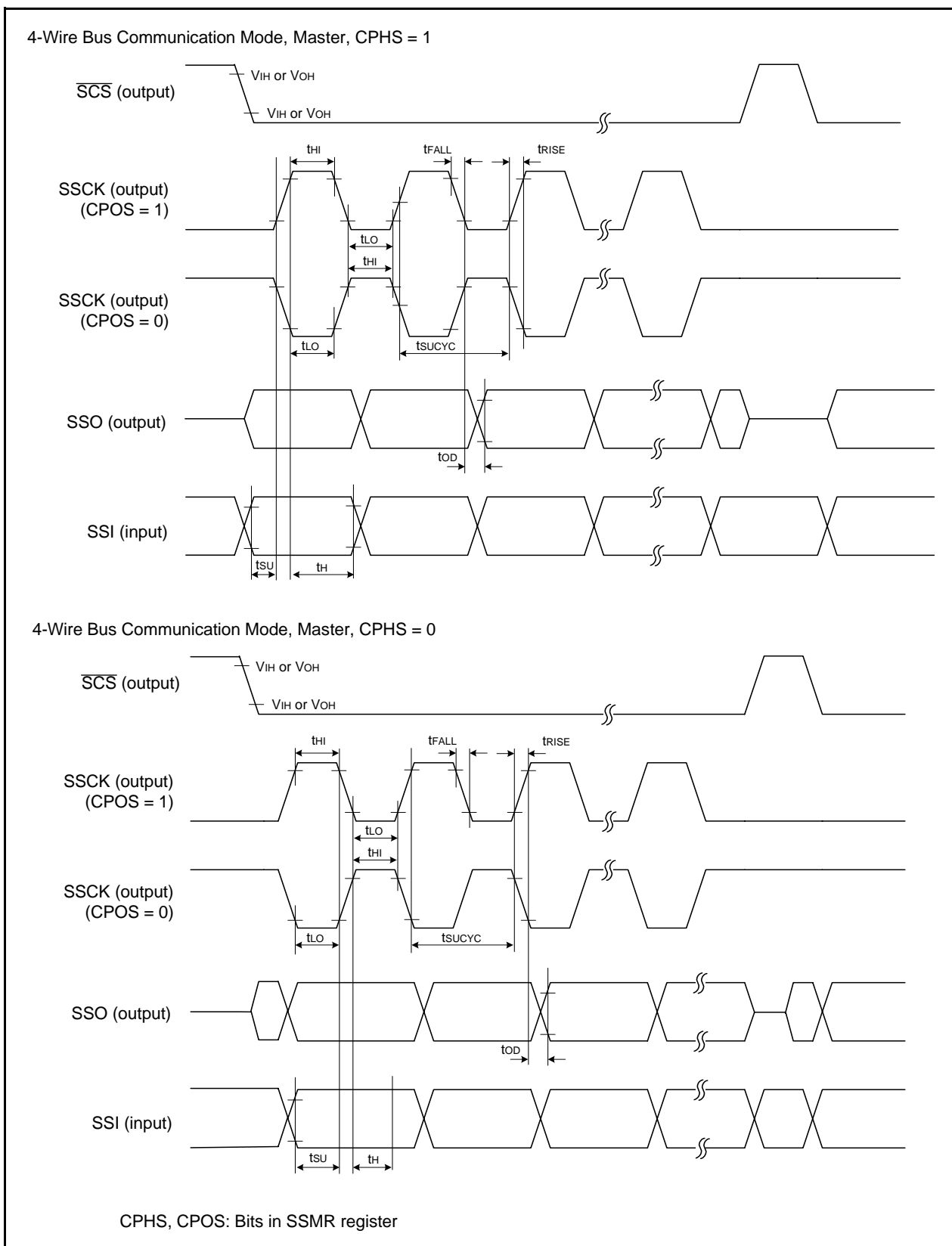


Figure 5.4 I/O Timing of Clock Synchronous Serial I/O with Chip Select (Master)

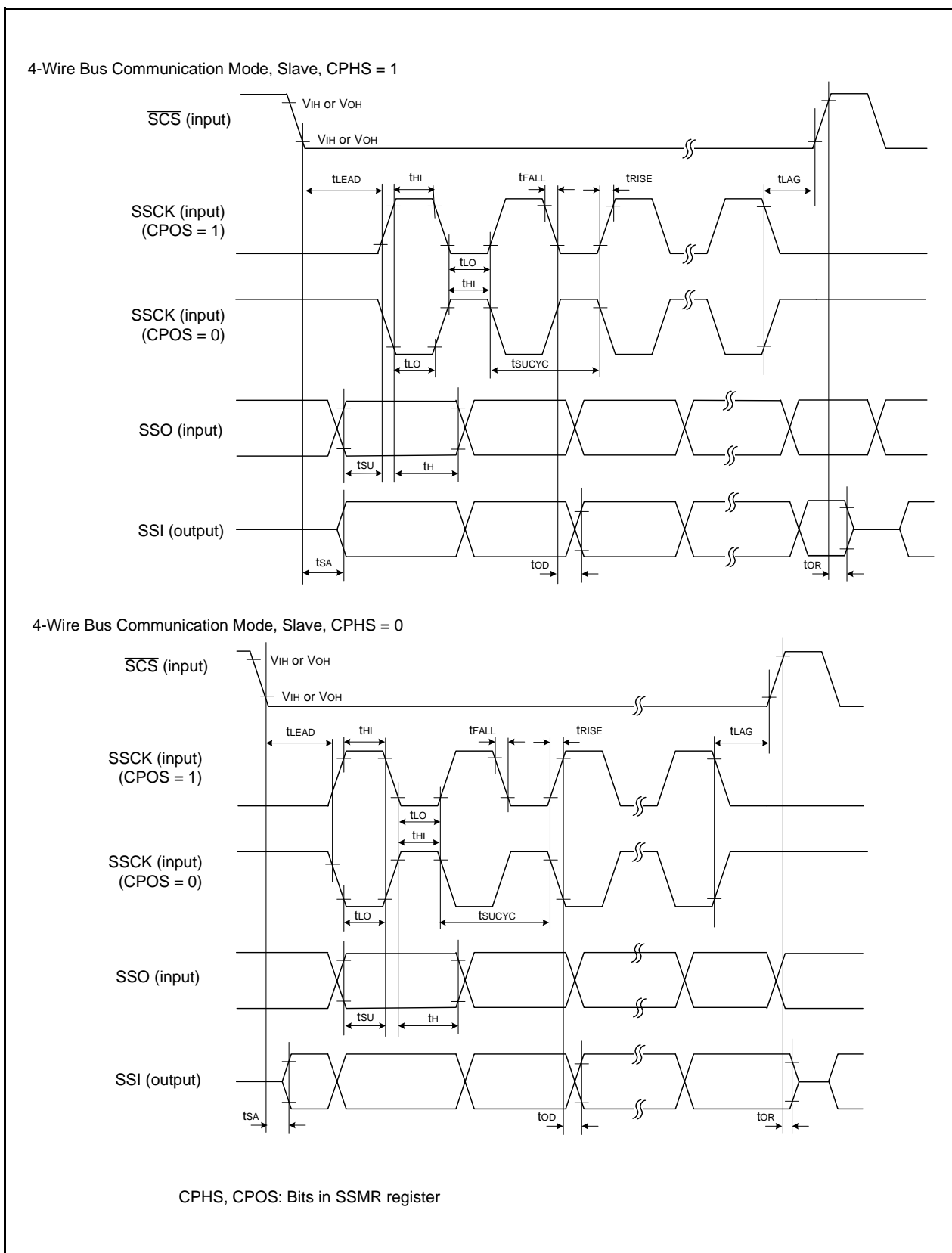


Figure 5.5 I/O Timing of Clock Synchronous Serial I/O with Chip Select (Slave)

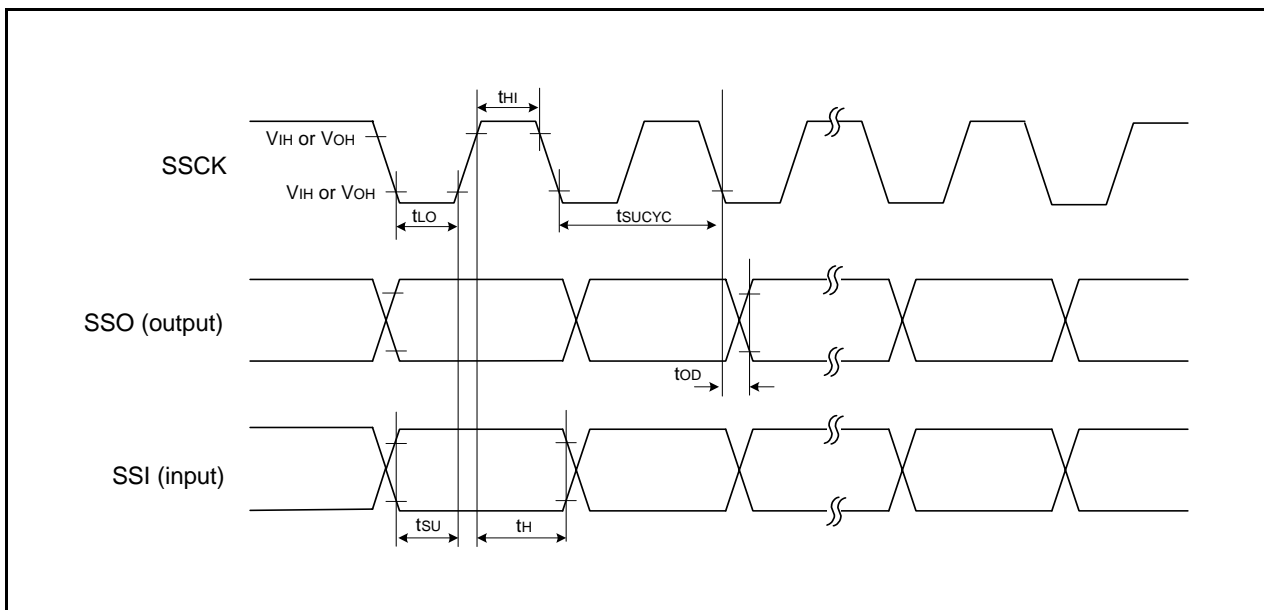


Figure 5.6 I/O Timing of Clock Synchronous Serial I/O with Chip Select (Clock Synchronous Communication Mode)

Table 5.14 Timing Requirements of I²C bus Interface(1)

| Symbol | Parameter | Condition | Standard | | | Unit |
|-------------------|---|-----------|---|------|----------------------------------|------|
| | | | Min. | Typ. | Max. | |
| t _{SCL} | SCL input cycle time | | 12t _{CYC} + 600 ⁽²⁾ | – | – | ns |
| t _{SCLH} | SCL input “H” width | | 3t _{CYC} + 300 ⁽²⁾ | – | – | ns |
| t _{SCLL} | SCL input “L” width | | 5t _{CYC} + 500 ⁽²⁾ | – | – | ns |
| t _{sf} | SCL, SDA input fall time | | – | – | 300 | ns |
| t _{SP} | SCL, SDA input spike pulse rejection time | | – | – | 1t _{CYC} ⁽²⁾ | ns |
| t _{BUF} | SDA input bus-free time | | 5t _{CYC} ⁽²⁾ | – | – | ns |
| t _{STAH} | Start condition input hold time | | 3t _{CYC} ⁽²⁾ | – | – | ns |
| t _{STAS} | Retransmit start condition input setup time | | 3t _{CYC} ⁽²⁾ | – | – | ns |
| t _{STOP} | Stop condition input setup time | | 3t _{CYC} ⁽²⁾ | – | – | ns |
| t _{SDAS} | Data input setup time | | 1t _{CYC} + 20 ⁽²⁾ | – | – | ns |
| t _{SDAH} | Data input hold time | | 0 | – | – | ns |

NOTES:

- V_{CC} = 2.2 to 5.5 V, V_{SS} = 0 V and T_{opr} = -20 to 85°C (N version) / -40 to 85°C (D version), unless otherwise specified.
- 1t_{CYC} = 1/f₁(s)

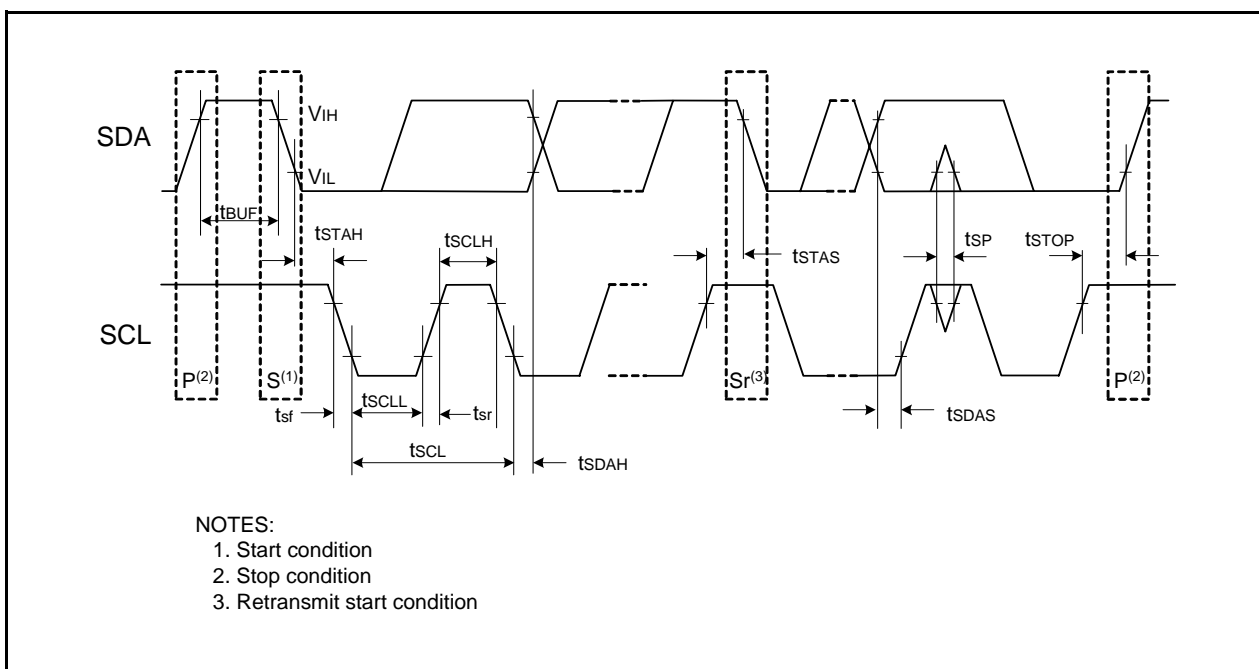


Figure 5.7 I/O Timing of I²C bus Interface

Table 5.15 Electrical Characteristics (1) [V_{CC} = 5 V]

| Symbol | Parameter | | Condition | Standard | | | Unit | | |
|----------------------------------|---------------------|---|---------------------------|--|-----------------------|------|-----------------|------|----|
| | | | | Min. | Typ. | Max. | | | |
| V _{OH} | Output "H" voltage | Except P2_0 to P2_7, XOUT | I _{OH} = -5 mA | | V _{CC} - 2.0 | - | V _{CC} | V | |
| | | | I _{OH} = -200 μA | | V _{CC} - 0.5 | - | V _{CC} | V | |
| | P2_0 to P2_7 | | Drive capacity HIGH | I _{OH} = -20 mA | V _{CC} - 2.0 | - | V _{CC} | V | |
| | | | Drive capacity LOW | I _{OH} = -5 mA | V _{CC} - 2.0 | - | V _{CC} | V | |
| | XOUT | | Drive capacity HIGH | I _{OH} = -1 mA | V _{CC} - 2.0 | - | V _{CC} | V | |
| | | | Drive capacity LOW | I _{OH} = -500 μA | V _{CC} - 2.0 | - | V _{CC} | V | |
| V _{OL} | Output "L" voltage | Except P2_0 to P2_7, XOUT | I _{OL} = 5 mA | | - | - | 2.0 | V | |
| | | | I _{OL} = 200 μA | | - | - | 0.45 | V | |
| | P2_0 to P2_7 | | Drive capacity HIGH | I _{OL} = 20 mA | - | - | 2.0 | V | |
| | | | Drive capacity LOW | I _{OL} = 5 mA | - | - | 2.0 | V | |
| | XOUT | | Drive capacity HIGH | I _{OL} = 1 mA | - | - | 2.0 | V | |
| | | | Drive capacity LOW | I _{OL} = 500 μA | - | - | 2.0 | V | |
| V _{T+} -V _{T-} | Hysteresis | INT0, INT1, INT2, INT3, KI0, KI1, KI2, KI3, TRAIO, RXD0, RXD1, CLK0, CLK1, SSI, SCL, SDA, SSO | | | 0.1 | 0.5 | - | V | |
| | | RESET | | | 0.1 | 1.0 | - | V | |
| I _{IH} | Input "H" current | | | V _I = 5 V, V _{CC} = 5V | | - | - | 5.0 | μA |
| I _{IL} | Input "L" current | | | V _I = 0 V, V _{CC} = 5V | | - | - | -5.0 | μA |
| R _{PULLUP} | Pull-up resistance | | | V _I = 0 V, V _{CC} = 5V | | 30 | 50 | 167 | kΩ |
| R _{IXIN} | Feedback resistance | XIN | | | - | 1.0 | - | | MΩ |
| R _{IXCIN} | Feedback resistance | XCIN | | | - | 18 | - | | MΩ |
| V _{RAM} | RAM hold voltage | | | During stop mode | | 1.8 | - | - | V |

NOTE:

- V_{CC} = 4.2 to 5.5 V at T_{opr} = -20 to 85°C (N version) / -40 to 85°C (D version), f(XIN) = 20 MHz, unless otherwise specified.

**Table 5.16 Electrical Characteristics (2) [V_{CC} = 5 V]
(T_{opr} = -20 to 85°C (N version) / -40 to 85°C (D version), unless otherwise specified.)**

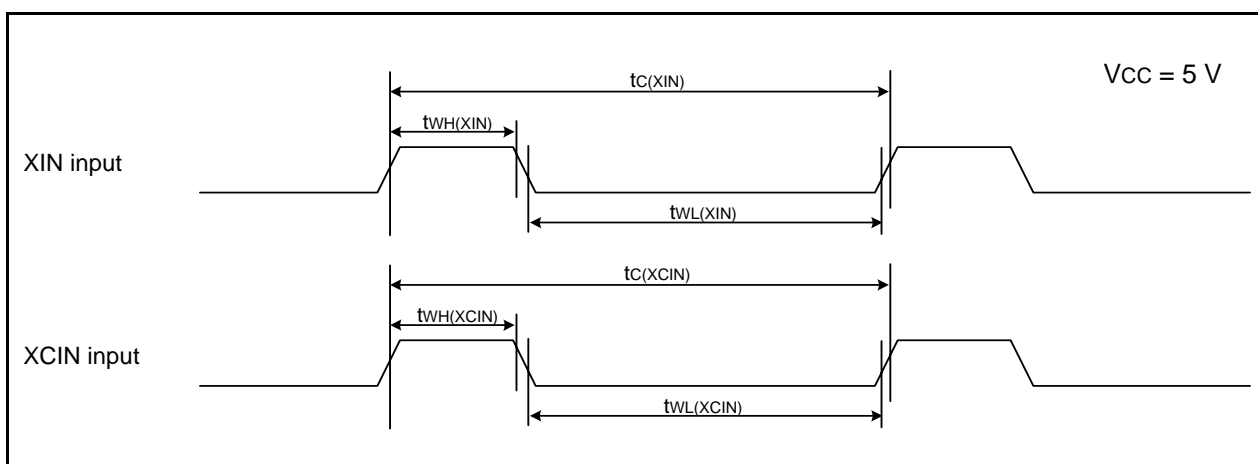
| Symbol | Parameter | Condition | Standard | | | Unit | |
|-----------------|---|--|--|------|------|------|----|
| | | | Min. | Typ. | Max. | | |
| I _{CC} | Power supply current (V _{CC} = 3.3 to 5.5 V) Single-chip mode, output pins are open, other pins are V _{SS} | High-speed clock mode | XIN = 20 MHz (square wave) High-speed on-chip oscillator off Low-speed on-chip oscillator on = 125 kHz No division | – | 10 | 17 | mA |
| | | | XIN = 16 MHz (square wave) High-speed on-chip oscillator off Low-speed on-chip oscillator on = 125 kHz No division | – | 9 | 15 | mA |
| | | | XIN = 10 MHz (square wave) High-speed on-chip oscillator off Low-speed on-chip oscillator on = 125 kHz No division | – | 6 | – | mA |
| | | | XIN = 20 MHz (square wave) High-speed on-chip oscillator off Low-speed on-chip oscillator on = 125 kHz Divide-by-8 | – | 5 | – | mA |
| | | | XIN = 16 MHz (square wave) High-speed on-chip oscillator off Low-speed on-chip oscillator on = 125 kHz Divide-by-8 | – | 4 | – | mA |
| | | | XIN = 10 MHz (square wave) High-speed on-chip oscillator off Low-speed on-chip oscillator on = 125 kHz Divide-by-8 | – | 2.5 | – | mA |
| | | High-speed on-chip oscillator mode | XIN clock off High-speed on-chip oscillator on f _{OCO} = 20 MHz Low-speed on-chip oscillator on = 125 kHz No division | – | 10 | 15 | mA |
| | | | XIN clock off High-speed on-chip oscillator on f _{OCO} = 20 MHz Low-speed on-chip oscillator on = 125 kHz Divide-by-8 | – | 4 | – | mA |
| | | | XIN clock off High-speed on-chip oscillator on f _{OCO} = 10 MHz Low-speed on-chip oscillator on = 125 kHz No division | – | 5.5 | 10 | mA |
| | | | XIN clock off High-speed on-chip oscillator on f _{OCO} = 10 MHz Low-speed on-chip oscillator on = 125 kHz Divide-by-8 | – | 2.5 | – | mA |
| | | Low-speed on-chip oscillator mode | XIN clock off High-speed on-chip oscillator off Low-speed on-chip oscillator on = 125 kHz Divide-by-8, FMR47 = 1 | – | 130 | 300 | μA |
| | | Low-speed clock mode | XIN clock off High-speed on-chip oscillator off Low-speed on-chip oscillator off XCIN clock oscillator on = 32 kHz FMR47 = 1 | – | 130 | 300 | μA |
| | | | XIN clock off High-speed on-chip oscillator off Low-speed on-chip oscillator off XCIN clock oscillator on = 32 kHz Program operation on RAM Flash memory off, FMSTP = 1 | – | 30 | – | μA |

**Table 5.17 Electrical Characteristics (3) [V_{CC} = 5 V]
(T_{opr} = -20 to 85°C (N version) / -40 to 85°C (D version), unless otherwise specified.)**

| Symbol | Parameter | Condition | Standard | | | Unit | |
|-----------------|---|---|--|------|------|------|----|
| | | | Min. | Typ. | Max. | | |
| I _{CC} | Power supply current (V _{CC} = 3.3 to 5.5 V) Single-chip mode, output pins are open, other pins are V _{SS} | Wait mode | XIN clock off High-speed on-chip oscillator off Low-speed on-chip oscillator on = 125 kHz While a WAIT instruction is executed Peripheral clock operation VCA27 = VCA26 = VCA25 = 0 VCA20 = 1 | – | 25 | 75 | μA |
| | | | XIN clock off High-speed on-chip oscillator off Low-speed on-chip oscillator on = 125 kHz While a WAIT instruction is executed Peripheral clock off VCA27 = VCA26 = VCA25 = 0 VCA20 = 1 | – | 23 | 60 | μA |
| | | | XIN clock off High-speed on-chip oscillator off Low-speed on-chip oscillator off XCIN clock oscillator on = 32 kHz (high drive) While a WAIT instruction is executed VCA27 = VCA26 = VCA25 = 0 VCA20 = 1 | – | 4.0 | – | μA |
| | | | XIN clock off High-speed on-chip oscillator off Low-speed on-chip oscillator off XCIN clock oscillator on = 32 kHz (low drive) While a WAIT instruction is executed VCA27 = VCA26 = VCA25 = 0 VCA20 = 1 | – | 2.2 | – | μA |
| | | Increase during A/D converter operation | Without sample & hold | – | 2.6 | – | mA |
| | | | With sample & hold | – | 1.6 | – | mA |
| | | Stop mode | XIN clock off, T _{opr} = 25°C High-speed on-chip oscillator off Low-speed on-chip oscillator off CM10 = 1 Peripheral clock off VCA27 = VCA26 = VCA25 = 0 | – | 0.8 | 3.0 | μA |
| | | | XIN clock off, T _{opr} = 85°C High-speed on-chip oscillator off Low-speed on-chip oscillator off CM10 = 1 Peripheral clock off VCA27 = VCA26 = VCA25 = 0 | – | 1.2 | – | μA |

Timing Requirements(Unless Otherwise Specified: $V_{CC} = 5\text{ V}$, $V_{SS} = 0\text{ V}$ at $T_{opr} = 25^\circ\text{C}$) [$V_{CC} = 5\text{ V}$]**Table 5.18 XIN Input, XCIN Input**

| Symbol | Parameter | Standard | | Unit |
|----------------|-----------------------|----------|------|---------------|
| | | Min. | Max. | |
| $t_{c(XIN)}$ | XIN input cycle time | 50 | – | ns |
| $t_{WH(XIN)}$ | XIN input "H" width | 25 | – | ns |
| $t_{WL(XIN)}$ | XIN input "L" width | 25 | – | ns |
| $t_{c(XCIN)}$ | XCIN input cycle time | 14 | – | μs |
| $t_{WH(XCIN)}$ | XCIN input "H" width | 7 | – | μs |
| $t_{WL(XCIN)}$ | XCIN input "L" width | 7 | – | μs |

**Figure 5.8 XIN Input and XCIN Input Timing Diagram when $V_{CC} = 5\text{ V}$** **Table 5.19 TRAIO Input**

| Symbol | Parameter | Standard | | Unit |
|-----------------|------------------------|----------|------|------|
| | | Min. | Max. | |
| $t_{c(TRAIO)}$ | TRAIO input cycle time | 100 | – | ns |
| $t_{WH(TRAIO)}$ | TRAIO input "H" width | 40 | – | ns |
| $t_{WL(TRAIO)}$ | TRAIO input "L" width | 40 | – | ns |

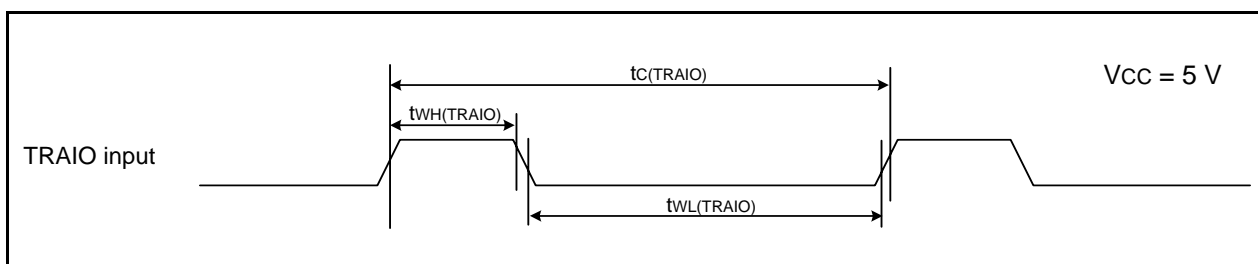
**Figure 5.9 TRAIO Input Timing Diagram when $V_{CC} = 5\text{ V}$**

Table 5.20 Serial Interface

| Symbol | Parameter | Standard | | Unit |
|---------------|------------------------|----------|------|------|
| | | Min. | Max. | |
| $t_{c(CK)}$ | CLKi input cycle time | 200 | – | ns |
| $t_{w(CKH)}$ | CLKi input “H” width | 100 | – | ns |
| $t_{w(CKL)}$ | CLKi input “L” width | 100 | – | ns |
| $t_{d(C-Q)}$ | TXDi output delay time | – | 50 | ns |
| $t_{h(C-Q)}$ | TXDi hold time | 0 | – | ns |
| $t_{su(D-C)}$ | RXDi input setup time | 50 | – | ns |
| $t_{h(C-D)}$ | RXDi input hold time | 90 | – | ns |

i = 0 or 1

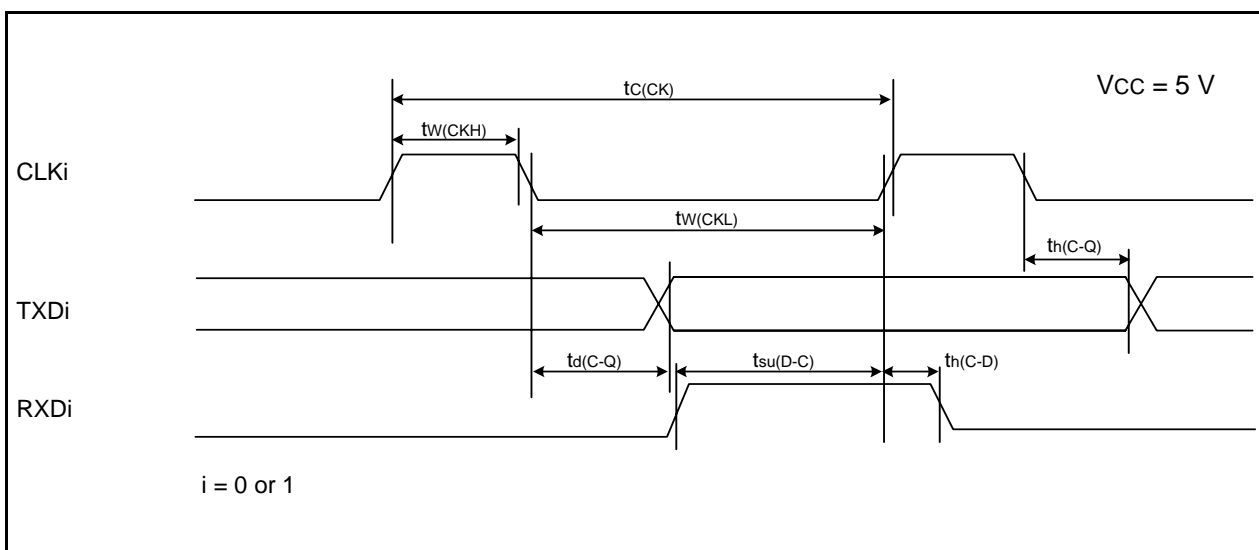


Figure 5.10 Serial Interface Timing Diagram when Vcc = 5 V

Table 5.21 External Interrupt \overline{INTi} (i = 0 to 3) Input

| Symbol | Parameter | Standard | | Unit |
|--------------|-----------------------------------|--------------------|------|------|
| | | Min. | Max. | |
| $t_{w(INH)}$ | $\overline{INT0}$ input “H” width | 250 ⁽¹⁾ | – | ns |
| $t_{w(INL)}$ | $\overline{INT0}$ input “L” width | 250 ⁽²⁾ | – | ns |

NOTES:

1. When selecting the digital filter by the \overline{INTi} input filter select bit, use an \overline{INTi} input HIGH width of either (1/digital filter clock frequency × 3) or the minimum value of standard, whichever is greater.
2. When selecting the digital filter by the \overline{INTi} input filter select bit, use an \overline{INTi} input LOW width of either (1/digital filter clock frequency × 3) or the minimum value of standard, whichever is greater.

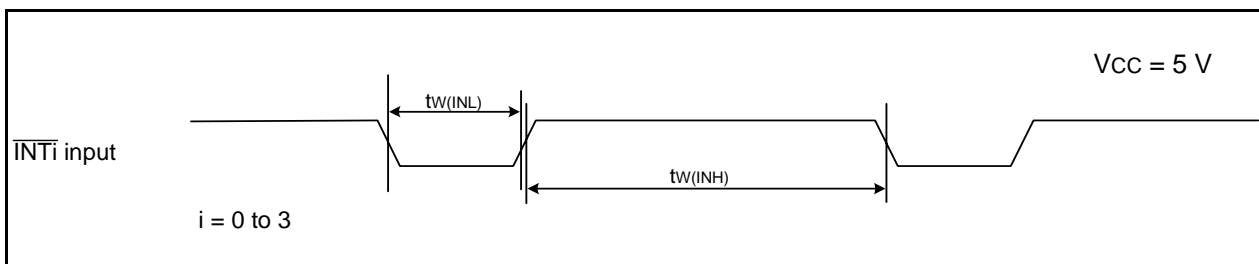


Figure 5.11 External Interrupt \overline{INTi} Input Timing Diagram when Vcc = 5 V

Table 5.22 Electrical Characteristics (3) [V_{CC} = 3 V]

| Symbol | Parameter | | Condition | | Standard | | | Unit |
|----------------------------------|---------------------|--|--|---------------------------|-----------------------|------|-----------------|------|
| | | | | | Min. | Typ. | Max. | |
| V _{OH} | Output "H" voltage | Except P2_0 to P2_7, XOUT | I _{OH} = -1 mA | | V _{CC} - 0.5 | – | V _{CC} | V |
| | | P2_0 to P2_7 | Drive capacity HIGH | I _{OH} = -5 mA | V _{CC} - 0.5 | – | V _{CC} | V |
| | | | Drive capacity LOW | I _{OH} = -1 mA | V _{CC} - 0.5 | – | V _{CC} | V |
| | | XOUT | Drive capacity HIGH | I _{OH} = -0.1 mA | V _{CC} - 0.5 | – | V _{CC} | V |
| | | | Drive capacity LOW | I _{OH} = -50 μA | V _{CC} - 0.5 | – | V _{CC} | V |
| V _{OL} | Output "L" voltage | Except P2_0 to P2_7, XOUT | I _{OL} = 1 mA | | – | – | 0.5 | V |
| | | P2_0 to P2_7 | Drive capacity HIGH | I _{OL} = 5 mA | – | – | 0.5 | V |
| | | | Drive capacity LOW | I _{OL} = 1 mA | – | – | 0.5 | V |
| | | XOUT | Drive capacity HIGH | I _{OL} = 0.1 mA | – | – | 0.5 | V |
| | | | Drive capacity LOW | I _{OL} = 50 μA | – | – | 0.5 | V |
| V _{T+} -V _{T-} | Hysteresis | <u>INT0</u> , <u>INT1</u> , <u>INT2</u> , <u>INT3</u> , <u>KI0</u> , <u>KI1</u> , <u>KI2</u> , <u>KI3</u> , <u>TRAIO</u> , <u>RXD0</u> , <u>RXD1</u> , <u>CLK0</u> , <u>CLK1</u> , <u>SSI</u> , <u>SCL</u> , <u>SDA</u> , <u>SSO</u> | | | 0.1 | 0.3 | – | V |
| | | <u>RESET</u> | | | 0.1 | 0.4 | – | V |
| I _{IH} | Input "H" current | | V _I = 3 V, V _{CC} = 3V | | – | – | 4.0 | μA |
| I _{IL} | Input "L" current | | V _I = 0 V, V _{CC} = 3V | | – | – | -4.0 | μA |
| R _{PULLUP} | Pull-up resistance | | V _I = 0 V, V _{CC} = 3V | | 66 | 160 | 500 | kΩ |
| R _{FXIN} | Feedback resistance | XIN | | | – | 3.0 | – | MΩ |
| R _{FXCIN} | Feedback resistance | XCIN | | | – | 18 | – | MΩ |
| V _{RAM} | RAM hold voltage | | During stop mode | | 1.8 | – | – | V |

NOTE:

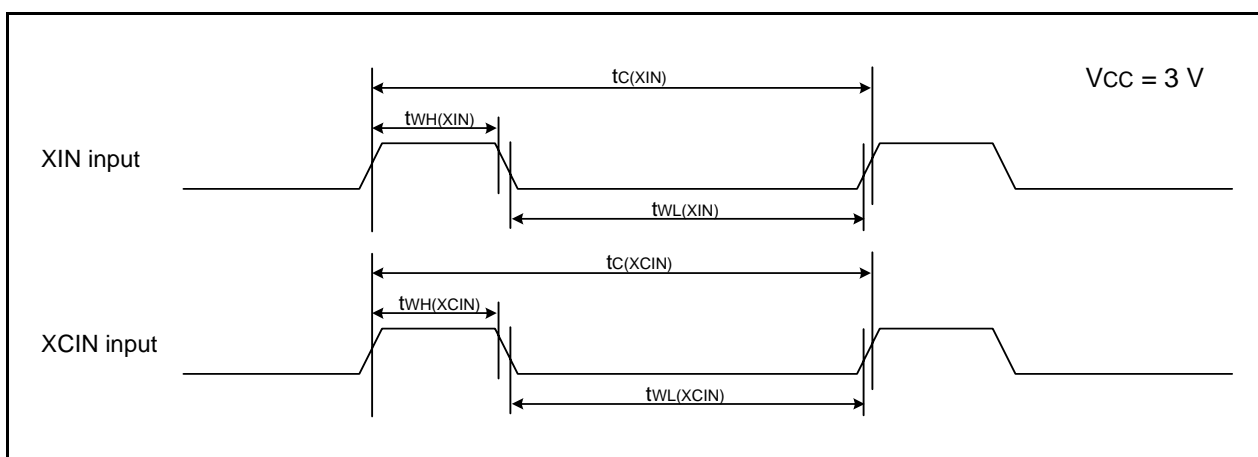
- V_{CC} = 2.7 to 3.3 V at T_{opr} = -20 to 85°C (N version) / -40 to 85°C (D version), f(XIN) = 10 MHz, unless otherwise specified.

**Table 5.23 Electrical Characteristics (4) [Vcc = 3 V]
(Topr = -20 to 85°C (N version) / -40 to 85°C (D version), unless otherwise specified.)**

| Symbol | Parameter | Condition | Standard | | | Unit | |
|--|---|---|--|------|------|------|----|
| | | | Min. | Typ. | Max. | | |
| Icc | Power supply current (Vcc = 2.7 to 3.3 V) Single-chip mode, output pins are open, other pins are Vss | High-speed clock mode | XIN = 10 MHz (square wave) High-speed on-chip oscillator off Low-speed on-chip oscillator on = 125 kHz No division | – | 6 | – | mA |
| | | | XIN = 10 MHz (square wave) High-speed on-chip oscillator off Low-speed on-chip oscillator on = 125 kHz Divide-by-8 | – | 2 | – | mA |
| | | High-speed on-chip oscillator mode | XIN clock off High-speed on-chip oscillator on fOCO = 10 MHz Low-speed on-chip oscillator on = 125 kHz No division | – | 5 | 9 | mA |
| | | | XIN clock off High-speed on-chip oscillator on fOCO = 10 MHz Low-speed on-chip oscillator on = 125 kHz Divide-by-8 | – | 2 | – | mA |
| | | Low-speed on-chip oscillator mode | XIN clock off High-speed on-chip oscillator off Low-speed on-chip oscillator on = 125 kHz Divide-by-8, FMR47 = 1 | – | 130 | 300 | μA |
| | | Low-speed clock mode | XIN clock off High-speed on-chip oscillator off Low-speed on-chip oscillator off XCIN clock oscillator on = 32 kHz FMR47 = 1 | – | 130 | 300 | μA |
| | | | XIN clock off High-speed on-chip oscillator off Low-speed on-chip oscillator off XCIN clock oscillator on = 32 kHz Program operation on RAM Flash memory off, FMSTP = 1 | – | 30 | – | μA |
| | | Wait mode | XIN clock off High-speed on-chip oscillator off Low-speed on-chip oscillator on = 125 kHz While a WAIT instruction is executed Peripheral clock operation VCA27 = VCA26 = VCA25 = 0 VCA20 = 1 | – | 25 | 70 | μA |
| | | | XIN clock off High-speed on-chip oscillator off Low-speed on-chip oscillator on = 125 kHz While a WAIT instruction is executed Peripheral clock off VCA27 = VCA26 = VCA25 = 0 VCA20 = 1 | – | 23 | 55 | μA |
| | | | XIN clock off High-speed on-chip oscillator off Low-speed on-chip oscillator off XCIN clock oscillator on = 32 kHz (high drive) While a WAIT instruction is executed VCA27 = VCA26 = VCA25 = 0 VCA20 = 1 | – | 3.8 | – | μA |
| | | | XIN clock off High-speed on-chip oscillator off Low-speed on-chip oscillator off XCIN clock oscillator on = 32 kHz (low drive) While a WAIT instruction is executed VCA27 = VCA26 = VCA25 = 0 VCA20 = 1 | – | 2.0 | – | μA |
| | | Increase during A/D converter operation | Without sample & hold | – | 0.9 | – | mA |
| | | | With sample & hold | – | 0.5 | – | mA |
| | | Stop mode | XIN clock off, Topr = 25°C High-speed on-chip oscillator off Low-speed on-chip oscillator off CM10 = 1 Peripheral clock off VCA27 = VCA26 = VCA25 = 0 | – | 0.7 | 3.0 | μA |
| XIN clock off, Topr = 85°C High-speed on-chip oscillator off Low-speed on-chip oscillator off CM10 = 1 Peripheral clock off VCA27 = VCA26 = VCA25 = 0 | – | | 1.1 | – | μA | | |

Timing requirements**(Unless Otherwise Specified: $V_{CC} = 3\text{ V}$, $V_{SS} = 0\text{ V}$ at $T_{op} = 25^\circ\text{C}$) [$V_{CC} = 3\text{ V}$]****Table 5.24 XIN Input, XCIN Input**

| Symbol | Parameter | Standard | | Unit |
|----------------|-----------------------|----------|------|---------------|
| | | Min. | Max. | |
| $t_{c(XIN)}$ | XIN input cycle time | 100 | – | ns |
| $t_{WH(XIN)}$ | XIN input "H" width | 40 | – | ns |
| $t_{WL(XIN)}$ | XIN input "L" width | 40 | – | ns |
| $t_{c(XCIN)}$ | XCIN input cycle time | 14 | – | μs |
| $t_{WH(XCIN)}$ | XCIN input "H" width | 7 | – | μs |
| $t_{WL(XCIN)}$ | XCIN input "L" width | 7 | – | μs |

**Figure 5.12 XIN Input and XCIN Input Timing Diagram when $V_{CC} = 3\text{ V}$** **Table 5.25 TRAI0 Input**

| Symbol | Parameter | Standard | | Unit |
|-----------------|------------------------|----------|------|------|
| | | Min. | Max. | |
| $t_{c(TRAIO)}$ | TRAIO input cycle time | 300 | – | ns |
| $t_{WH(TRAIO)}$ | TRAIO input "H" width | 120 | – | ns |
| $t_{WL(TRAIO)}$ | TRAIO input "L" width | 120 | – | ns |

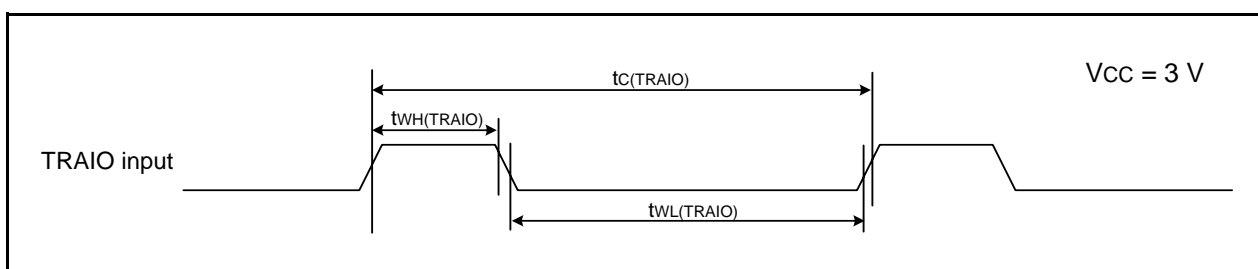
**Figure 5.13 TRAI0 Input Timing Diagram when $V_{CC} = 3\text{ V}$**

Table 5.26 Serial Interface

| Symbol | Parameter | Standard | | Unit |
|---------------|------------------------|----------|------|------|
| | | Min. | Max. | |
| $t_{c(CK)}$ | CLKi input cycle time | 300 | – | ns |
| $t_{w(CKH)}$ | CLKi input “H” width | 150 | – | ns |
| $t_{w(CKL)}$ | CLKi Input “L” width | 150 | – | ns |
| $t_{d(C-Q)}$ | TXDi output delay time | – | 80 | ns |
| $t_{h(C-Q)}$ | TXDi hold time | 0 | – | ns |
| $t_{su(D-C)}$ | RXDi input setup time | 70 | – | ns |
| $t_{h(C-D)}$ | RXDi input hold time | 90 | – | ns |

i = 0 or 1

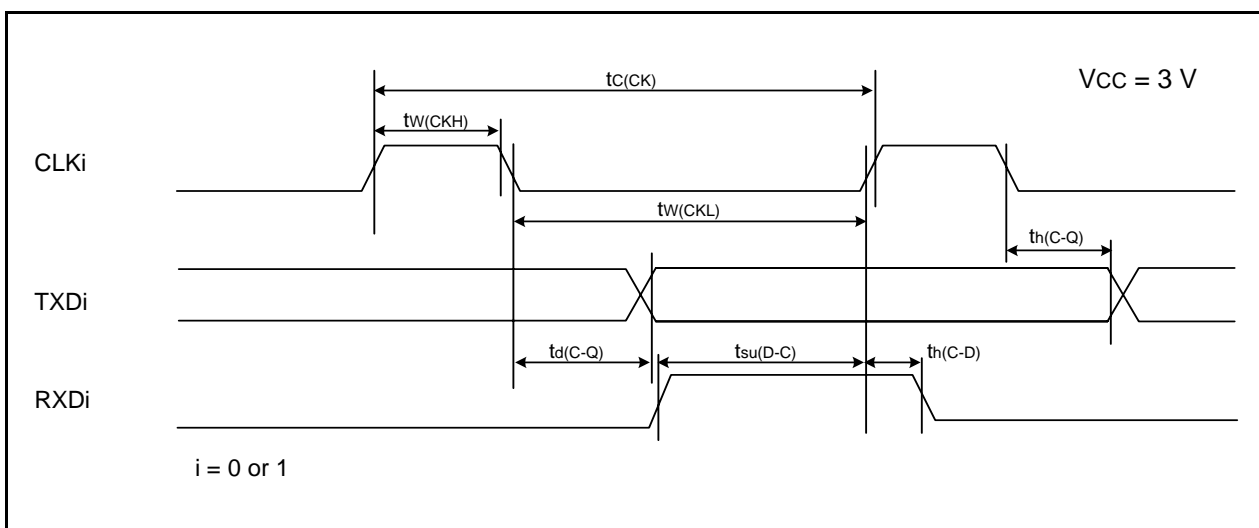


Figure 5.14 Serial Interface Timing Diagram when Vcc = 3 V

Table 5.27 External Interrupt \overline{INTi} (i = 0 to 3) Input

| Symbol | Parameter | Standard | | Unit |
|--------------|-----------------------------------|--------------------|------|------|
| | | Min. | Max. | |
| $t_{w(INH)}$ | $\overline{INT0}$ input “H” width | 380 ⁽¹⁾ | – | ns |
| $t_{w(INL)}$ | $\overline{INT0}$ input “L” width | 380 ⁽²⁾ | – | ns |

NOTES:

1. When selecting the digital filter by the \overline{INTi} input filter select bit, use an \overline{INTi} input HIGH width of either (1/digital filter clock frequency × 3) or the minimum value of standard, whichever is greater.
2. When selecting the digital filter by the \overline{INTi} input filter select bit, use an \overline{INTi} input LOW width of either (1/digital filter clock frequency × 3) or the minimum value of standard, whichever is greater.

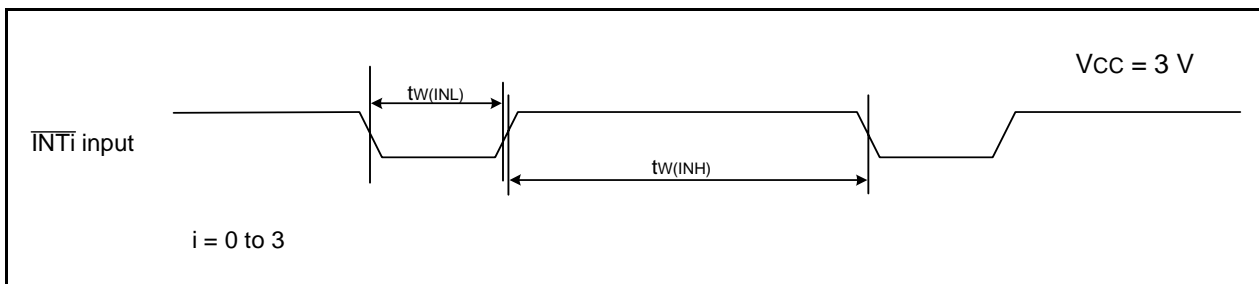


Figure 5.15 External Interrupt \overline{INTi} Input Timing Diagram when Vcc = 3 V

Table 5.28 Electrical Characteristics (5) [V_{CC} = 2.2 V]

| Symbol | Parameter | | Condition | | Standard | | | Unit |
|----------------------------------|---------------------|--|-------------------------|---------------------------|-----------------------|------|-----------------|------|
| | | | | | Min. | Typ. | Max. | |
| V _{OH} | Output "H" voltage | Except P2_0 to P2_7, XOUT | I _{OH} = -1 mA | | V _{CC} - 0.5 | – | V _{CC} | V |
| | | P2_0 to P2_7 | Drive capacity HIGH | I _{OH} = -2 mA | V _{CC} - 0.5 | – | V _{CC} | V |
| | | | Drive capacity LOW | I _{OH} = -1 mA | V _{CC} - 0.5 | – | V _{CC} | V |
| | | XOUT | Drive capacity HIGH | I _{OH} = -0.1 mA | V _{CC} - 0.5 | – | V _{CC} | V |
| | | | Drive capacity LOW | I _{OH} = -50 μA | V _{CC} - 0.5 | – | V _{CC} | V |
| V _{OL} | Output "L" voltage | Except P2_0 to P2_7, XOUT | I _{OL} = 1 mA | | – | – | 0.5 | V |
| | | P2_0 to P2_7 | Drive capacity HIGH | I _{OL} = 2 mA | – | – | 0.5 | V |
| | | | Drive capacity LOW | I _{OL} = 1 mA | – | – | 0.5 | V |
| | | XOUT | Drive capacity HIGH | I _{OL} = 0.1 mA | – | – | 0.5 | V |
| | | | Drive capacity LOW | I _{OL} = 50 μA | – | – | 0.5 | V |
| V _{T+} -V _{T-} | Hysteresis | <u>INT0</u> , <u>INT1</u> , <u>INT2</u> , <u>INT3</u> , <u>KI0</u> , <u>KI1</u> , <u>KI2</u> , <u>KI3</u> , <u>TRAIO</u> , <u>RXD0</u> , <u>RXD1</u> , <u>CLK0</u> , <u>CLK1</u> , <u>SSI</u> , <u>SCL</u> , <u>SDA</u> , <u>SSO</u> | | | 0.05 | 0.3 | – | V |
| | | <u>RESET</u> | | | 0.05 | 0.15 | – | V |
| I _{IH} | Input "H" current | V _I = 2.2 V | | – | – | 4.0 | μA | |
| I _{IL} | Input "L" current | V _I = 0 V | | – | – | -4.0 | μA | |
| R _{PULLUP} | Pull-up resistance | V _I = 0 V | | 100 | 200 | 600 | kΩ | |
| R _{FXIN} | Feedback resistance | XIN | | | – | 5 | – | MΩ |
| R _{FXCIN} | Feedback resistance | XCIN | | | – | 35 | – | MΩ |
| V _{RAM} | RAM hold voltage | During stop mode | | 1.8 | – | – | V | |

NOTE:

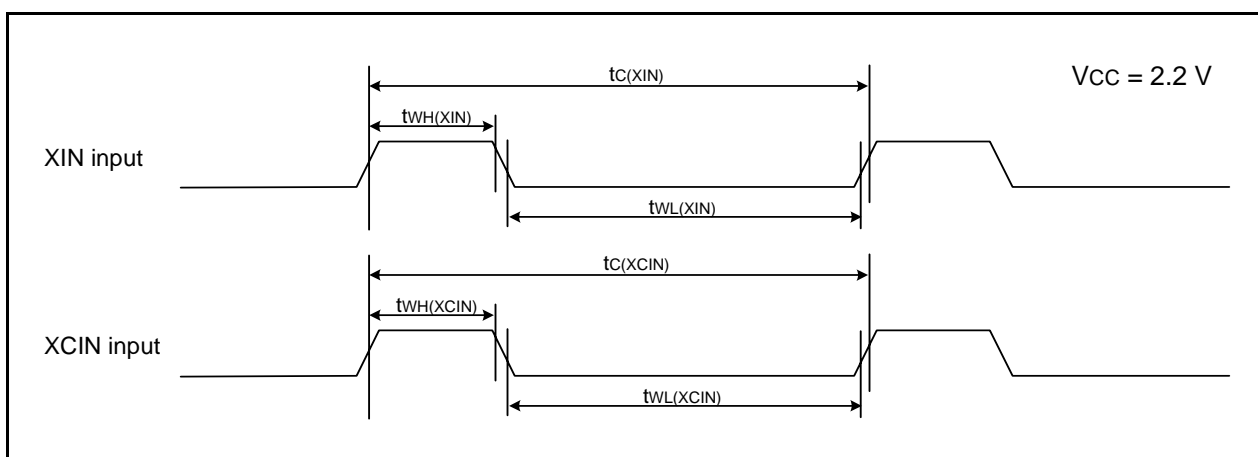
- V_{CC} = 2.2 V at T_{opr} = -20 to 85°C (N version) / -40 to 85°C (D version), f(XIN) = 5 MHz, unless otherwise specified.

**Table 5.29 Electrical Characteristics (6) [Vcc = 2.2 V]
(Topr = -20 to 85°C (N version) / -40 to 85°C (D version), unless otherwise specified.)**

| Symbol | Parameter | Condition | Standard | | | Unit | |
|--|---|---|--|------|------|------|----|
| | | | Min. | Typ. | Max. | | |
| Icc | Power supply current (Vcc = 2.2 to 2.7 V) Single-chip mode, output pins are open, other pins are Vss | High-speed clock mode | XIN = 5 MHz (square wave) High-speed on-chip oscillator off Low-speed on-chip oscillator on = 125 kHz No division | – | 3.5 | – | mA |
| | | | XIN = 5 MHz (square wave) High-speed on-chip oscillator off Low-speed on-chip oscillator on = 125 kHz Divide-by-8 | – | 1.5 | – | mA |
| | | High-speed on-chip oscillator mode | XIN clock off High-speed on-chip oscillator on fOCO = 5 MHz Low-speed on-chip oscillator on = 125 kHz No division | – | 3.5 | – | mA |
| | | | XIN clock off High-speed on-chip oscillator on fOCO = 5 MHz Low-speed on-chip oscillator on = 125 kHz Divide-by-8 | – | 1.5 | – | mA |
| | | Low-speed on-chip oscillator mode | XIN clock off High-speed on-chip oscillator off Low-speed on-chip oscillator on = 125 kHz Divide-by-8, FMR47 = 1 | – | 100 | 230 | μA |
| | | Low-speed clock mode | XIN clock off High-speed on-chip oscillator off Low-speed on-chip oscillator off XCIN clock oscillator on = 32 kHz FMR47 = 1 | – | 100 | 230 | μA |
| | | | XIN clock off High-speed on-chip oscillator off Low-speed on-chip oscillator off XCIN clock oscillator on = 32 kHz Program operation on RAM Flash memory off, FMSTP = 1 | – | 25 | – | μA |
| | | Wait mode | XIN clock off High-speed on-chip oscillator off Low-speed on-chip oscillator on = 125 kHz While a WAIT instruction is executed Peripheral clock operation VCA27 = VCA26 = VCA25 = 0 VCA20 = 1 | – | 22 | 60 | μA |
| | | | XIN clock off High-speed on-chip oscillator off Low-speed on-chip oscillator on = 125 kHz While a WAIT instruction is executed Peripheral clock off VCA27 = VCA26 = VCA25 = 0 VCA20 = 1 | – | 20 | 55 | μA |
| | | | XIN clock off High-speed on-chip oscillator off Low-speed on-chip oscillator off XCIN clock oscillator on = 32 kHz (high drive) While a WAIT instruction is executed VCA27 = VCA26 = VCA25 = 0 VCA20 = 1 | – | 3.0 | – | μA |
| | | | XIN clock off High-speed on-chip oscillator off Low-speed on-chip oscillator off XCIN clock oscillator on = 32 kHz (low drive) While a WAIT instruction is executed VCA27 = VCA26 = VCA25 = 0 VCA20 = 1 | – | 1.8 | – | μA |
| | | Increase during A/D converter operation | Without sample & hold | – | 0.4 | – | mA |
| | | | With sample & hold | – | 0.3 | – | mA |
| | | Stop mode | XIN clock off, Topr = 25°C High-speed on-chip oscillator off Low-speed on-chip oscillator off CM10 = 1 Peripheral clock off VCA27 = VCA26 = VCA25 = 0 | – | 0.7 | 3.0 | μA |
| XIN clock off, Topr = 85°C High-speed on-chip oscillator off Low-speed on-chip oscillator off CM10 = 1 Peripheral clock off VCA27 = VCA26 = VCA25 = 0 | – | | 1.1 | – | μA | | |

Timing requirements**(Unless Otherwise Specified: $V_{CC} = 2.2\text{ V}$, $V_{SS} = 0\text{ V}$ at $T_{opr} = 25^\circ\text{C}$) [$V_{CC} = 2.2\text{ V}$]****Table 5.30 XIN Input, XCIN Input**

| Symbol | Parameter | Standard | | Unit |
|----------------|-----------------------|----------|------|---------------|
| | | Min. | Max. | |
| $t_{c(XIN)}$ | XIN input cycle time | 200 | – | ns |
| $t_{WH(XIN)}$ | XIN input "H" width | 90 | – | ns |
| $t_{WL(XIN)}$ | XIN input "L" width | 90 | – | ns |
| $t_{c(XCIN)}$ | XCIN input cycle time | 14 | – | μs |
| $t_{WH(XCIN)}$ | XCIN input "H" width | 7 | – | μs |
| $t_{WL(XCIN)}$ | XCIN input "L" width | 7 | – | μs |

**Figure 5.16 XIN Input and XCIN Input Timing Diagram when $V_{CC} = 2.2\text{ V}$** **Table 5.31 TRAI0 Input**

| Symbol | Parameter | Standard | | Unit |
|-----------------|------------------------|----------|------|------|
| | | Min. | Max. | |
| $t_{c(TRAIO)}$ | TRAIO input cycle time | 500 | – | ns |
| $t_{WH(TRAIO)}$ | TRAIO input "H" width | 200 | – | ns |
| $t_{WL(TRAIO)}$ | TRAIO input "L" width | 200 | – | ns |

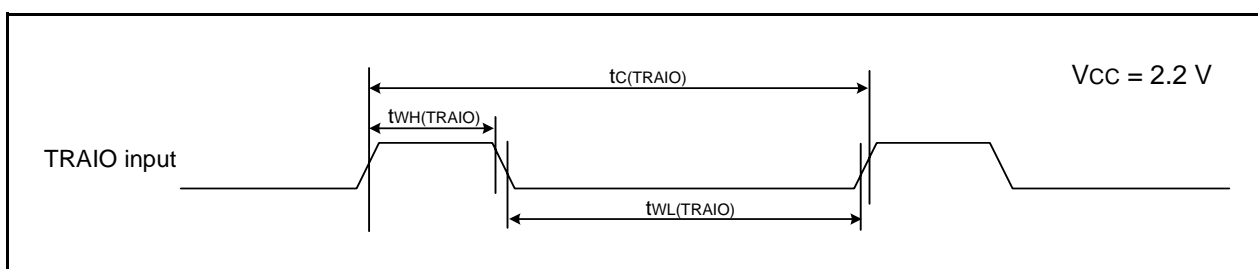
**Figure 5.17 TRAI0 Input Timing Diagram when $V_{CC} = 2.2\text{ V}$**

Table 5.32 Serial Interface

| Symbol | Parameter | Standard | | Unit |
|---------------|------------------------|----------|------|------|
| | | Min. | Max. | |
| $t_{c(CK)}$ | CLKi input cycle time | 800 | – | ns |
| $t_{w(CKH)}$ | CLKi input “H” width | 400 | – | ns |
| $t_{w(CKL)}$ | CLKi input “L” width | 400 | – | ns |
| $t_{d(C-Q)}$ | TXDi output delay time | – | 200 | ns |
| $t_{h(C-Q)}$ | TXDi hold time | 0 | – | ns |
| $t_{su(D-C)}$ | RXDi input setup time | 150 | – | ns |
| $t_{h(C-D)}$ | RXDi input hold time | 90 | – | ns |

i = 0 or 1

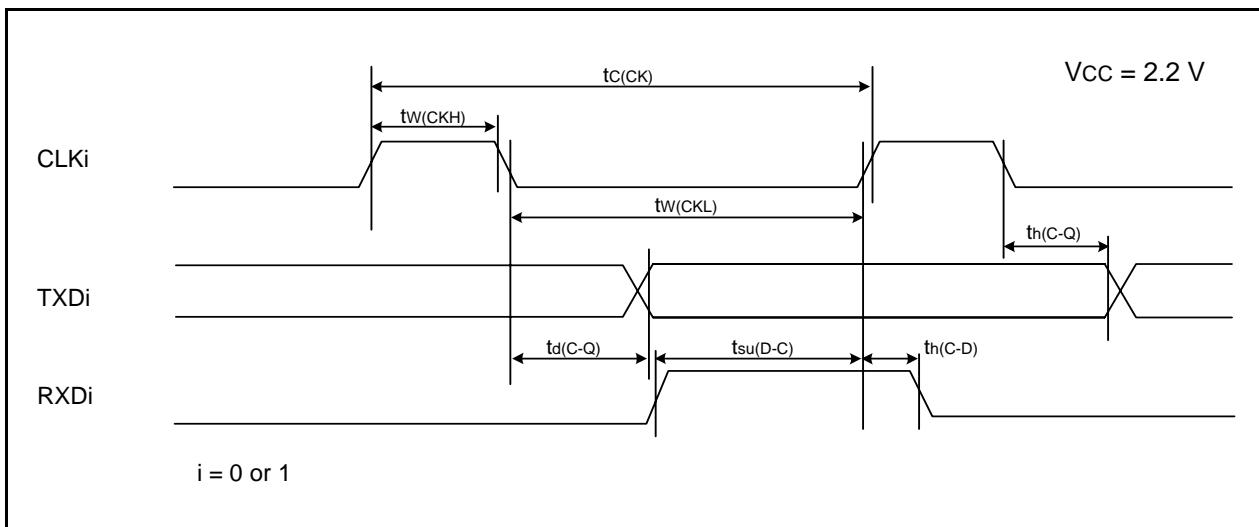


Figure 5.18 Serial Interface Timing Diagram when Vcc = 2.2 V

Table 5.33 External Interrupt \overline{INTi} (i = 0 to 3) Input

| Symbol | Parameter | Standard | | Unit |
|--------------|-----------------------------------|---------------------|------|------|
| | | Min. | Max. | |
| $t_{w(INH)}$ | $\overline{INT0}$ input “H” width | 1000 ⁽¹⁾ | – | ns |
| $t_{w(INL)}$ | $\overline{INT0}$ input “L” width | 1000 ⁽²⁾ | – | ns |

NOTES:

1. When selecting the digital filter by the \overline{INTi} input filter select bit, use an \overline{INTi} input HIGH width of either (1/digital filter clock frequency × 3) or the minimum value of standard, whichever is greater.
2. When selecting the digital filter by the \overline{INTi} input filter select bit, use an \overline{INTi} input LOW width of either (1/digital filter clock frequency × 3) or the minimum value of standard, whichever is greater.

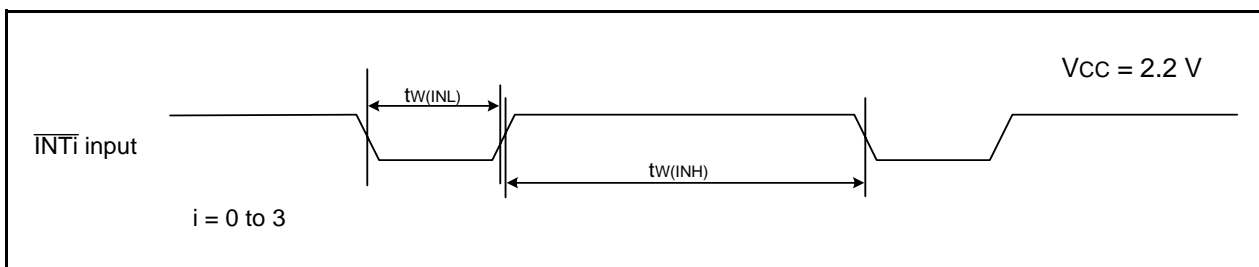


Figure 5.19 External Interrupt \overline{INTi} Input Timing Diagram when Vcc = 2.2 V

Package Dimensions

Diagrams showing the latest package dimensions and mounting information are available in the “Packages” section of the Renesas Technology website.

| | | | |
|---|-------------------------------|--------------------------|--------------------|
| JEITA Package Code P-LQFP52-10x10-0.65 | RENEASAS Code PLQP0052JA-A | Previous Code 52P6A-A | MASS[Typ.] 0.3g |
|---|-------------------------------|--------------------------|--------------------|

Under development

NOTE)
 1. DIMENSIONS “*1” AND “*2” DO NOT INCLUDE MOLD FLASH.
 2. DIMENSION “*3” DOES NOT INCLUDE TRIM OFFSET.

| Reference Symbol | Dimension in Millimeters | | |
|------------------|--------------------------|-------|------|
| | Min | Nom | Max |
| D | 9.9 | 10.0 | 10.1 |
| E | 9.9 | 10.0 | 10.1 |
| A ₂ | — | 1.4 | — |
| H _D | 11.8 | 12.0 | 12.2 |
| H _E | 11.8 | 12.0 | 12.2 |
| A | — | — | 1.7 |
| A ₁ | 0.05 | 0.1 | 0.15 |
| b _p | 0.27 | 0.32 | 0.37 |
| b ₁ | — | 0.30 | — |
| c | 0.09 | 0.145 | 0.20 |
| c ₁ | — | 0.125 | — |
| φ | 0° | — | 8° |
| ⓪ | — | 0.65 | — |
| x | — | — | 0.13 |
| y | — | — | 0.10 |
| Z _D | — | 1.1 | — |
| Z _E | — | 1.1 | — |
| L | 0.35 | 0.5 | 0.65 |
| L ₁ | — | 1.0 | — |

| | | | |
|--|-------------------------------|------------------------|---------------------|
| JEITA Package Code P-TFLGA64-6x6-0.65 | RENEASAS Code PTLG0064JA-A | Previous Code 64F0G | MASS[Typ.] 0.07g |
|--|-------------------------------|------------------------|---------------------|

| Reference Symbol | Dimension in Millimeters | | |
|------------------|--------------------------|------|------|
| | Min | Nom | Max |
| D | — | 6.0 | — |
| E | — | 6.0 | — |
| v | — | — | 0.15 |
| w | — | — | 0.20 |
| A | — | — | 1.05 |
| ⓪ | — | 0.65 | — |
| b | 0.31 | 0.35 | 0.39 |
| b ₁ | 0.39 | 0.43 | 0.47 |
| x | — | — | 0.08 |
| y | — | — | 0.10 |

REVISION HISTORY

R8C/24 Group, R8C/25 Group Datasheet

| Rev. | Date | Description | |
|------|--------------|-------------|---|
| | | Page | Summary |
| 0.01 | Sep 17, 2004 | - | First Edition issued |
| 0.02 | Dec 10, 2004 | All pages | Part Number revised. R8C/26 → R8C/24, R8C/27 → R8C/25 |
| | | 2, 3 | Table 1.1 R8C/24 Group Performance, Table 1.2 R8C/25 Group Performance - Serial Interface: I ² C Bus Interface and Chip-select clock synchronous (SSU) added. - LIN Module added. - Interrupt: Internal factors revised; 10 → 11 - Note on Operating Ambient Temperature added. |
| | | 4 | Figure 1.1 Block Diagram - LIN Module added. - Chip-select clock synchronous (SSU) is added to I ² C Bus Interface. |
| | | 5, 6 | Table 1.3 Product Information of R8C/24 Group, Table 1.4 Product Information of R8C/25 Group Date and Development state revised. |
| | | 7 | Figure 1.4 Pin Assignment P3_5/SCL → P3_5/SCL/SSCK, P3_3 → P3_3/SSI, P3_4/SDA → P3_4/SDA/SCS, P3_7 → P3_7/SSO, VSS/AVSS → VSS, XIN/P4_6 → P4_6/XIN, VCC/AVSS → VCC 12pin P1_7/TRAI0/INT1 to 22pin P1_0/KI0/AN8 → 20pin P1_7/TRAI0/INT1 to 30pin P1_0/KI0/AN8 |
| | | 8 | Table 1.5 Pin Description - Analog Power Supply Input eliminated. - SSU added. |
| | | 9 | Table 1.6 Pin Name Information by Pin Number added. |
| | | 15 | Table 4.1 SFR Information (1) - 0031h: Voltage Detection Register 1 → Voltage Detection <u>A</u> Register 1 - 0032h: Voltage Detection Register 1 → Voltage Detection <u>A</u> Register 2 01000001b → 00100001b (Note 4) - 0036h: “(3), 01000001b (4)” eliminated. - 0038h: Voltage Monitor 0 Control Register (2), VW0C, 00001000b (3), 01000001b (4) added. |
| | | 16 | Table 4.2 SFR Information (2) - 0048h: Timer RD0 Interrupt Control Register, RD0IC, XXXXX000b added. - 0049h: Timer RD Interrupt Control Register, RDIC → Timer RD1 Interrupt Control Register, RD1IC - 004Fh: IIC Interrupt Control Register, IIC → IIC/SSU Interrupt Control Register, IIC2IC |
| | | 19 | Table 4.5 SFR Information (3) - 0106h: LIN Control Register, LINCR, 00h added. - 0107h: LIN Status Register, LINST, 00h added. |

REVISION HISTORY

R8C/24 Group, R8C/25 Group Datasheet

| Rev. | Date | Description | |
|------|--------------|--|--|
| | | Page | Summary |
| 0.10 | Feb 24, 2005 | 1 to 3 5, 6 5 to 7 8 9 13, 14 15 17 19 20 | <p>Pin type changed: 48-pin(under consideration) → 52-pin.</p> <p>Package type revised: 48-pin LQFP(under consideration) → PLQP0052JA-A</p> <p>Table 1.5 TCLK added, VREF revised.</p> <p>Table 1.6 revised.</p> <p>Figures 3.1 and 3.2 part number revised.</p> <p>Tabel 4.1 revised: - 000Fh: 000XXXXXb → 00011111b - 0023h: FR0 → FRA0 - 0024h: FR1 → FRA1 - 0025h: FR2 → FRA2 - 0031h: Voltage Detection A Register 1, VC1 → Voltage Detection Register 1, VCA1 - 0032h: Voltage Detection A Register 2, VC2 → Voltage Detection Register 2, VCA2</p> <p>Tabel 4.3 Register name and the value after reset at 00B8h to 00BFh revised; NOTE2 added.</p> <p>Tabel 4.5 revised: - 0107h: LINSR → LINST - 0137h to 013Fh: Register symbol revised</p> <p>Tabel 4.6 revised: - 0140h to 015Fh: Register symbol revised - 0158h, 0159h: Timer RD General Register → Timer RD General Register A1</p> |
| 0.20 | Mar 8, 2005 | 2, 3 8 15 | <p>Tables 1.1, 1.2 and 1.5 revised: "main clock" → "XIN clock"; "sub clock" → "XCIN clock"</p> <p>- 0023h to 0025h: 40MHz On-Chip Oscillator Control Register → High-Speed On-Chip Oscillator Control Register</p> |
| 0.30 | Sep 01, 2005 | 2, 3 4 5, 6 | <p>Table 1.1 R8C/24 Group Performance, Table 1.2 R8C/25 Group Performance</p> <ul style="list-style-type: none"> • Serial Interface revised: <ul style="list-style-type: none"> - Serial Interface: 2 channels Clock synchronous serial I/O, UART - Clock Synchronous Serial Interface: 1 channel I²C bus Interface⁽¹⁾, Clock synchronous serial I/O with chip select <p>Figure 1.1 Block Diagram</p> <ul style="list-style-type: none"> • UART or Clock Synchronous Serial Interface: "(8 bits × 1 channel)" → "(8 bits × 2 channels)" revised • UART (8 bits × 1 channel) deleted <p>Table 1.3 Product Information of R8C/24 Group, Table 1.4 Product Information of R8C/25 Group "Flash Memory Version" → "N Version" revised</p> |

| Rev. | Date | Description | |
|------|--------------|-------------|--|
| | | Page | Summary |
| 0.30 | Sep 01, 2005 | 7 | <p>Figure 1.4 Pin Assignment</p> <ul style="list-style-type: none"> Pin name revised; <ul style="list-style-type: none"> VSS → VSS/AVSS, VCC → VCC/AVCC, P1_5/RXD0/(TRAIO)/(INT1) → P1_5/RXD0/(TRAIO)/(INT1)⁽²⁾, P6_6/INT2/(TXD1) → P6_6/INT2/TXD1, P6_7/INT3/(RXD1) → P6_7/INT3/RXD1, P6_5 → P6_5/CLK1 NOTE2 added |
| | | 8 | <p>Table 1.5 Pin Description</p> <ul style="list-style-type: none"> Analog Power Supply Input: line added INT Interrupt Input: "INT0 Timer RD input pins. INT1 Timer RA input pins." added Serial Interface: "CLK1" added "I²C Bus Interface (IIC)" → "I²C Bus Interface" "SSU" → "Clock Synchronous Serial I/O with Chip Select" |
| | | 9 | <p>Table 1.6 Pin Name Information by Pin Number revised</p> <ul style="list-style-type: none"> Pin Number 10: "VSS" → "VSS/AVSS" Pin Number 12: "VCC" → "VCC/AVCC" Pin Number 27: "INT0" added Pin Number 28: "(TXD1)" → "TXD1" Pin Number 29: "(RXD1)" → "RXD1" Pin Number 35: "CLK1" added |
| | | 15 | <p>Tabel 4.1 SFR Information(1) revised:</p> <ul style="list-style-type: none"> 0012h: X0h → 00h 0013h: XXXXX00b → 00h 0016h: X0h → 00h 0036h: Voltage Monitor 1 Control Register⁽²⁾ → Voltage Monitor 1 Control Register⁽⁵⁾ 0038h: 00001000b⁽³⁾, 01000001b⁽⁴⁾ → 0000X000b⁽³⁾, 0100X001b⁽⁴⁾ NOTES2, 5: "the voltage monitor 1 reset" added NOTE3: "voltage monitor 1 reset" → "voltage monitor 0 reset" |
| | | 16 | <p>Tabel 4.2 SFR Information(2) revised:</p> <ul style="list-style-type: none"> 0048h: RD0IC → TRD0IC 0049h: RD1IC → TRD1IC 004Ah: REIC → TREIC 004Fh: SSU/IIC Interrupt Control Register, IIC2AIC → SSU/IIC Interrupt Control Register⁽²⁾, SSUAIC/IIC2AIC 0056h: RAIC → TRAIC 0058h: RBIC → TRBIC NOTE2 added |
| | | 17 | <p>Tabel 4.3 SFR Information(3) revised:</p> <ul style="list-style-type: none"> 00BCh: 00h → 00h/0000X000b |
| | | 18 | <p>Tabel 4.4 SFR Information(4) revised:</p> <ul style="list-style-type: none"> 00D6h: 00000XXXb → 00h 00F5h: UART1 Function Select Register, U1SR, XXh added |

REVISION HISTORY

R8C/24 Group, R8C/25 Group Datasheet

| Rev. | Date | Description | |
|------|--------------|-------------|---|
| | | Page | Summary |
| 0.30 | Sep 01, 2005 | 19 | Tabel 4.5 SFR Information(5) revised: • 0118h : Timer RE Second Data Register/Counter Register → Timer RE Second Data Register/Counter Data Register |
| | | 20 | Tabel 4.6 SFR Information(6) revised: • 0145h POCR0 → TRDPOCR0 • 0146h, 0147h TRDCNT0 → TRD0 • 0148h, 0149h GRA0 → TRDGRA0 • 014Ah, 014Bh GRB0 → TRDGRB0 • 014Ch, 014Dh GRC0 → TRDGRC0 • 014Eh, 014Fh GRD0 → TRDGRD0 • 0155h POCR1 → TRDPOCR1 • 0156h, 0157h TRDCNT1 → TRD1 • 0158h, 0159h GRA1 → TRDGRA1 • 015Ah, 015Bh GRB1 → TRDGRB1 • 015Ch, 015Dh GRC1 → TRDGRC1 • 015Eh, 015Fh GRD1 → TRDGRD1 |
| | | 21 | Tabel 4.7 SFR Information(7) revised: • 01B5h: 01000101b → 1000000Xb • 01B7h: XX000001b → 00000001b • FFFFh: (Note 2) added |
| | | 22 to 44 | 5. Electrical Characteristics added |
| | | | |
| 0.40 | Jan 24, 2006 | all pages | • “Preliminary” deleted • Symbol name “TRDMDR” → “TRDMR”, “SSUAIC” → “SSUIC”, and “IIC2AIC” → “IICIC” revised • Pin name “TCLK” → “TRDCLK” revised |
| | | 2 | Table 1.1 Functions and Specifications for R8C/24 Group revised |
| | | 3 | Table 1.2 Functions and Specifications for R8C/25 Group revised |
| | | 4 | Figure 1.1 Block Diagram; “Peripheral Functions” added, “System Clock Generation” → “System Clock Generator” revised |
| | | 5 | Table 1.3 Product Information for R8C/24 Group revised |
| | | 6 | Table 1.4 Product Information for R8C/25 Group revised |
| | | 7 | Figure 1.4 Pin Assignments (Top View) “TCLK” → “TRDCLK” revised |
| | | 8 | Table 1.5 Pin Functions “TCLK” → “TRDCLK” revised |
| | | 9 | Table 1.6 Pin Name Information by Pin Number; “TCLK” → “TRDCLK” revised |
| | | 10 | Figure 2.1 CPU Registers; “Reserved Area” → “Reserved Bit” revised |
| | | 12 | 2.8.10 Reserved Area; “Reserved Area” → “Reserved bit” revised |
| | | 13 | Figure 3.1 Memory Map of R8C/24 Group; “Program area” → “program ROM” revised |
| | | 14 | 3.2 R8C/25 Group, Figure 3.2 Memory Map of R8C/25 Group; “Data area” → “data flash”, “Program area” → “program ROM” revised |

REVISION HISTORY

R8C/24 Group, R8C/25 Group Datasheet

| Rev. | Date | Description | |
|------|--------------|-------------|---|
| | | Page | Summary |
| 0.40 | Jan 24, 2006 | 15 | Table 4.1 SFR Information(1); 0024h: "TBD" → "When shipping" NOTES 3 and 4 revised |
| | | 19 | Table 4.5 SFR Information (5); 0118h: "Timer RE Second Data Register" → "Timer RE Second Data Register / Counter Data Register" 0119h: "Timer RE Minute Data Register" → "Timer RE Minute Data Register / Compare Data Register" 0138h: "TRDMDR" → "TRDMR" 013Bh: "Timer RD Output Master Enable Register" → "Timer RD Output Master Enable Register 1" |
| | | 22 | Table 5.1 Absolute Maximum Ratings; "VCC" → "VCC/AVCC" revised Table 5.2 Recommended Operating Conditions revised |
| | | 23 | Table 5.3 A/D Converter Characteristics revised |
| | | 24 | Table 5.4 Flash Memory (Program ROM) Electrical Characteristics revised |
| | | 25 | Table 5.5 Flash Memory (Data flash Block A, Block B) Electrical revised |
| | | 26 | Table 5.6 Voltage Detection 0 Circuit Electrical Characteristics revised Table 5.7 Voltage Detection 1 Circuit Electrical Characteristics revised Table 5.8 Voltage Detection 2 Circuit Electrical Characteristics revised |
| | | 28 | Table 5.11 High-speed On-Chip Oscillator Circuit Electrical Characteristics revised Table 5.12 Low-speed On-Chip Oscillator Circuit Electrical Characteristics revised Table 5.13 Power Supply Circuit Timing Characteristics revised |
| | | 29 | Table 5.14 Timing Requirements of Clock Synchronous Serial I/O with Chip Select revised |
| | | 33 | Table 5.15 Timing Requirements of I ² C bus Interface NOTE1 revised |
| | | 34 | Table 5.16 Electrical Characteristics (1) [VCC = 5 V] revised |
| | | 35 | Table 5.17 Electrical Characteristics (2) [VCC = 5 V] revised |
| | | 36 | Table 5.18 XIN Input, XCIN Input revised |
| | | 37 | Table 5.20 Serial Interface revised |
| | | 38 | Table 5.22 Electrical Characteristics (3) [VCC = 3 V] revised |
| | | 39 | Table 5.23 Electrical Characteristics (4) [Vcc = 3 V] revised |
| | | 40 | Table 5.24 XIN Input, XCIN Input revised |
| | | 41 | Table 5.26 Serial Interface revised |
| | | 42 | Table 5.28 Electrical Characteristics (5) [Vcc = 2.2 V] revised |
| | | 43 | Table 5.29 Electrical Characteristics (6) [Vcc = 2.2 V] revised |
| | | 44 | Table 5.30 XIN Input, XCIN Input revised Table 5.31 TRAI0 Input, INT1 Input revised |
| | | 45 | Table 5.32 Serial Interface revised Table 5.33 External Interrupt INTi (i = 0, 2, 3) Input |

REVISION HISTORY

R8C/24 Group, R8C/25 Group Datasheet

| Rev. | Date | Description | |
|------|--------------|-------------|--|
| | | Page | Summary |
| 0.40 | Jan 24, 2006 | 46 | Package Dimensions; "TBD" → "PLQP0052JA-A (52P6A-A)" added |
| 1.00 | May 31, 2006 | all pages | "Under development" deleted |
| | | 1 | 1. Overview; "data flash ROM" → "data flash" revised |
| | | 3 | Table 1.2 Functions and Specifications for R8C/25 Group revised |
| | | 4 | Figure 1.1 Block Diagram; "System clock generator" → "System clock generation circuit" revised |
| | | 5 to 6 | Table 1.3 Product Information for R8C/24 Group and Table 1.4 Product Information for R8C/25 Group; A part of (D) mark is deleted. |
| | | 9 | Table 1.6 Pin Name Information by Pin Number NOTE1 added |
| | | 15 | Table 4.1 SFR Information(1); 001Ch: "00h" → "00h, 10000000b" revised 0029h: High-Speed On-Chip Oscillator Control Register 4 FRA4 When shipping added 002Bh: High-Speed On-Chip Oscillator Control Register 6 FRA6 When shipping added NOTE6 added |
| | | 19 | Table 4.5 SFR Information(5); 0118h: Timer RE Second Data Register / Counter Data Register, 0119h: Timer RE Minute Data Register / Compare Data Register register name revised |
| | | 20 | Table 4.6 SFR Information(6); 0143h: "11000000b" → "11100000b" revised |
| | | 22 | Table 5.2 Recommended Operating Conditions revised |
| | | 24 | Table 5.4 Flash Memory (Program ROM) Electrical Characteristics revised |
| | | 25 | Table 5.5 Flash Memory (Data flash Block A, Block B) Electrical Characteristics revised |
| | | 26 | Figure 5.2 Time delay until Suspend title revised |
| | | 27 | Table 5.9 Voltage Monitor 0 Reset Electrical Characteristics → Table 5.9 Power-on Reset Circuit, Voltage Monitor 0 Reset Electrical Characteristics revised Table 5.10 Power-on Reset Circuit Electrical Characteristics (When Not Using Voltage Monitor 0 Reset) deleted Figure 5.3 Power-on Reset Circuit Electrical Characteristics revised |
| | | 28 | Table 5.10 High-speed On-Chip Oscillator Circuit Electrical Characteristics revised Table 5.11 Low-speed On-Chip Oscillator Circuit Electrical Characteristics revised |
| | | 35 | Table 5.16 Electrical Characteristics (2) [Vcc = 5 V] revised |
| | | 39 | Table 5.22 Electrical Characteristics (4) [Vcc = 3 V] revised |
| | | 43 | Table 5.28 Electrical Characteristics (6) [Vcc = 2.2 V] revised |
| | | 46 | Package Dimensions; "The latest package ... Renesas Technology website." added |

REVISION HISTORY

R8C/24 Group, R8C/25 Group Datasheet

| Rev. | Date | Description | | | |
|--------|--|-------------|---|-----------|--|
| | | Page | Summary | | |
| 2.00 | Jul 14, 2006 | all pages | "PTLG0064JA-A (64F0G)" package added | | |
| | | 1 | 1. Overview; "... or a 64-pin molded-plastic FLGA." added | | |
| | | 2, 3 | Table 1.1 Functions and Specifications for R8C/24 Group, Table 1.2 Functions and Specifications for R8C/25 Group; Package: "64-pin molded-plastic FLGA" added | | |
| | | 5 | Table 1.3 Product Information for R8C/24 Group, Figure 1.2 Type Number, Memory Size, and Package of R8C/24 Group revised | | |
| | | 6 | Table 1.4 Product Information for R8C/25 Group, Figure 1.3 Type Number, Memory Size, and Package of R8C/25 Group revised | | |
| | | 7 | Figure 1.4 PLQP0052JA-A Package Pin Assignments (Top View); NOTE3 revised | | |
| | | 8 | Figure 1.5 PTLG0064JA-A Package Pin Assignments added | | |
| | | 14 | Figure 3.1 Memory Map of R8C/24 Group revised | | |
| | | 15 | Figure 3.2 Memory Map of R8C/25 Group revised | | |
| | | 23 | Table 5.1 Absolute Maximum Ratings; NOTE1 added | | |
| | | 47 | Package Dimensions; "PTLG0064JA-A (64F0G)" added | | |
| | | 3.00 | Feb 29, 2008 | all pages | Y version added Factory programming product added |
| | | | | 2, 3 | Table 1.1, Table 1.2 Clock; "Real-time clock (timer RE)" added |
| 5, 7 | Table 1.3, Table 1.4 revised | | | | |
| 6, 8 | Figure 1.2, Figure 1.3; ROM number "XXX" added | | | | |
| 16, 17 | Figure 3.1, Figure 3.2; "Expanded area" deleted | | | | |
| 18 | Table 4.1 revised | | | | |
| 26 | Table 5.2 NOTE2 revised | | | | |
| 32 | Table 5.10; revised, NOTE4 added Table 5.11; Oscillation stability time: Condition "Vcc = 5.0 V, Topr = 25°C" deleted | | | | |
| 38 | Table 5.15; I _{IH} , I _{IL} , R _{PULLUP} Condition: "Vcc = 5V" added | | | | |
| 39 | Table 5.16; Condition: High-speed on-chip oscillator mode revised | | | | |
| 40 | Table 5.17 added | | | | |
| 41 | Figure 5.8 revised | | | | |
| 43 | Table 5.22; I _{IH} , I _{IL} , R _{PULLUP} Condition: "Vcc = 3V" added | | | | |
| 44 | Table 5.23; Condition "Increase during A/D converter operation" added | | | | |
| 45 | Figure 5.12 revised | | | | |
| 48 | Table 5.29; Condition "Increase during A/D converter operation" added | | | | |
| 49 | Figure 5.16 revised | | | | |

Notes:

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